

## EiceDRIVER™ 1ED38x0Mc12M Enhanced

### Datasheet

Single-channel 5.7 kV (rms) isolated gate driver IC with I2C configurability for DESAT, Soft-off, UVLO, Miller clamp and optional two-level turn-off

### Features

- 650 V, 1200 V, 1700 V, 2300 V IGBTs, SiC, and Si MOSFETs
- 40 V absolute maximum output supply voltage
- $\pm 3$  A,  $\pm 6$  A, and  $\pm 9$  A typical sinking and sourcing peak output current
- Separate source and sink outputs for hard switching or optional two-level turn-off and with active Miller clamp
- I2C bus for parameter configuration and status register readout
- Precise, adjustable, and temperature compensated  $V_{CEsat}$  detection (DESAT) with fault output
- Adjustable IGBT soft turn-off after desaturation detection
- Operation at high ambient temperature up to 125 °C with over-temperature shut down at 160 °C ( $\pm 10$  °C)
- Tight IC-to-IC propagation delay matching ( $t_{PDD,max} = 30$  ns)
- Undervoltage lockout protection with hysteresis for input and output side with active shut-down
- Configurable feedback or fault-off behavior for comparator result of integrated ADC
- High common-mode transient immunity CMTI = 200 kV/ $\mu$ s
- Small space-saving DSO-16 fine-pitch package with large creepage distance (>8 mm)
- Safety certification
  - UL 1577 recognized (File E311313) with  $V_{ISO,test} = 6840$  V (rms) for 1 s,  $V_{ISO} = 5700$  V (rms) for 60 s
  - VDE 0884-11 approval (Certificate no. 40053980) with  $V_{IORM} = 1767$  V (peak, reinforced)
- Additional [reference manual](#) available for detailed functional description

### Potential applications

- Industrial motor drives - compact, standard, premium, servo drives
- Solar inverters
- UPS systems
- Welding
- Commercial and agricultural vehicles (CAV)
- Commercial air-conditioning (CAC)
- High-voltage isolated DC-DC converters
- Isolated switch mode power supplies (SMPS)



PG-DSO-16

### Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

**Device information**

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Product type	Output current	Isolation class	Marking	OPN
1ED3830MC12M	3 A (typ)	reinforced	3830MC12	<a href="#">1ED3830MC12MXUMA1</a>
1ED3860MC12M	6 A (typ)	reinforced	3860MC12	<a href="#">1ED3860MC12MXUMA1</a>
1ED3890MC12M	9 A (typ)	reinforced	3890MC12	<a href="#">1ED3890MC12MXUMA1</a>
1ED3830MU12M	3 A (typ)	UL 1577	3830MU12	<a href="#">1ED3830MU12MXUMA1</a>
1ED3860MU12M	6 A (typ)	UL 1577	3860MU12	<a href="#">1ED3860MU12MXUMA1</a>
1ED3890MU12M	9 A (typ)	UL 1577	3890MU12	<a href="#">1ED3890MU12MXUMA1</a>

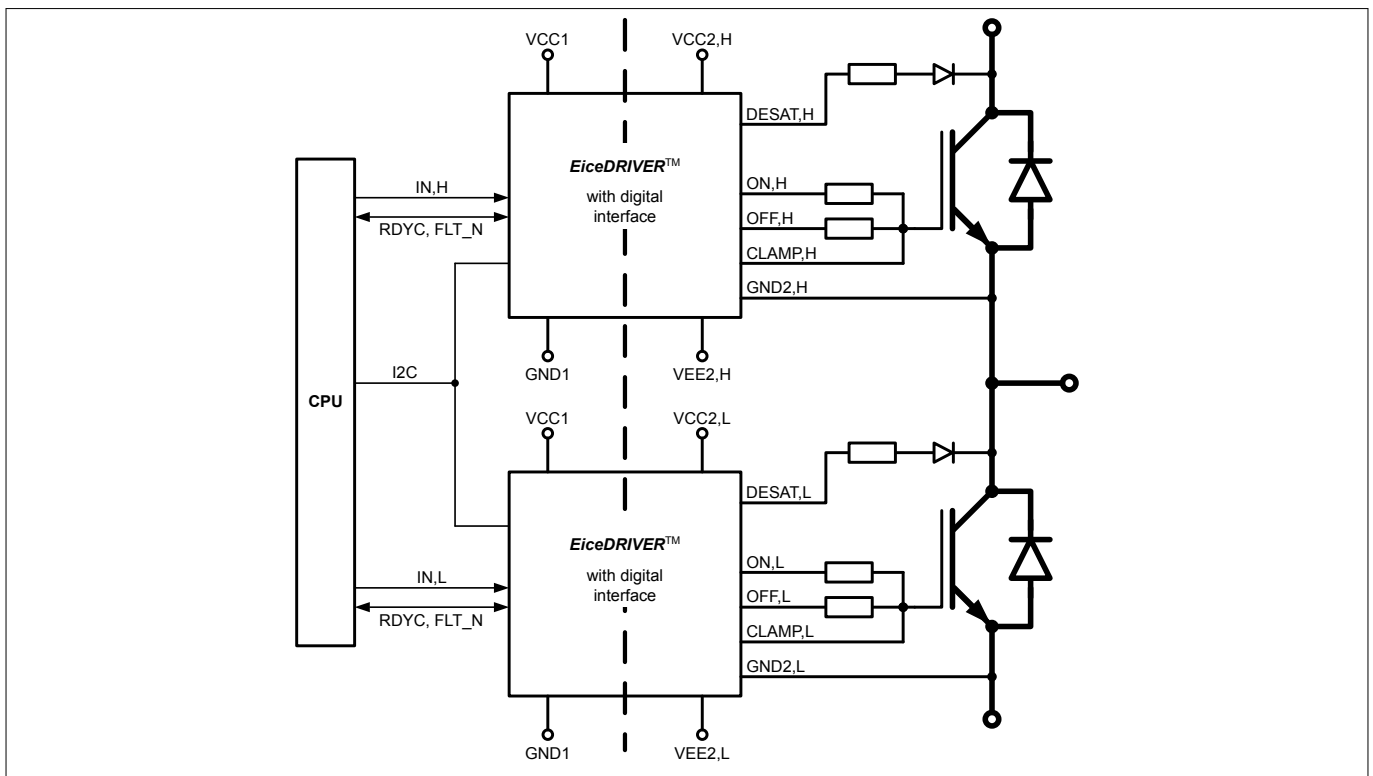
**Description**

The 1ED38x0Mc12M family (X3 Digital) consists of galvanically isolated single channel gate driver ICs in a small PG-DSO-16 package with a large creepage and clearance of 8 mm. The gate driver ICs provide a typical peak output current of 3 A, 6 A, and 9 A.

Adjustable control and protection functions are included to simplify the design of highly reliable systems. All parameter adjustments are done from the input side via the I2C interface (pin SDA and SCL).

All logic I/O pins are supply voltage dependent 3.3 V or 5 V CMOS compatible and can be directly connected to a microcontroller.

The data transfer across the galvanic isolation is realized by the integrated coreless transformer technology.



**Figure 1** Typical application

## Table of contents

	<b>Table of contents</b> .....	3
<b>1</b>	<b>Block diagram</b> .....	5
<b>2</b>	<b>Related products</b> .....	6
<b>3</b>	<b>Pin configuration and functionality</b> .....	7
3.1	Pin configuration .....	7
3.2	Pin functionality .....	8
3.3	Configurable parameters via I2C .....	10
<b>4</b>	<b>Functional description</b> .....	11
4.1	Start-up and fault clearing .....	11
4.2	Supply .....	12
4.3	Input side logic .....	13
4.4	I2C bus .....	13
4.5	Operating states .....	15
4.6	Measurement .....	15
4.7	Monitoring .....	16
4.8	Desaturation protection .....	18
4.8.1	DESAT behavior .....	18
4.9	Gate driver output .....	20
4.9.1	Turn-on behavior .....	21
4.9.2	Turn-off and fault turn-off behavior .....	21
4.9.2.1	Hard switching turn-off .....	22
4.9.2.2	Two-level turn-off .....	22
4.9.2.3	Soft turn-off .....	23
4.9.3	Active shut-down .....	24
4.9.4	Active Miller clamp .....	24
4.10	Short circuit clamping .....	24
<b>5</b>	<b>Electrical parameters</b> .....	25
5.1	Absolute maximum ratings .....	25
5.2	Thermal parameters .....	26
5.3	Operating parameters .....	26
5.4	Electrical characteristics .....	28
5.4.1	Voltage supply .....	28
5.4.2	Logic input and output .....	30
5.4.3	Gate driver .....	31
5.4.4	Active Miller clamp .....	32
5.4.5	Dynamic characteristics .....	33
5.4.6	Desaturation protection .....	35
5.4.7	Two-level turn-off .....	39

**Table of contents**

5.4.8	Soft-off current source .....	40
5.4.9	Over-temperature protection .....	41
5.4.10	ADC measurement .....	42
<b>6</b>	<b>Insulation characteristics</b> .....	<b>43</b>
6.1	Certified according to VDE 0884-11 reinforced insulation (Certificate no. 40053980) .....	43
6.2	Recognized under UL 1577 (File E311313) .....	44
<b>7</b>	<b>Package information</b> .....	<b>45</b>
	<b>Revision history</b> .....	<b>45</b>
	<b>Disclaimer</b> .....	<b>46</b>

1 Block diagram

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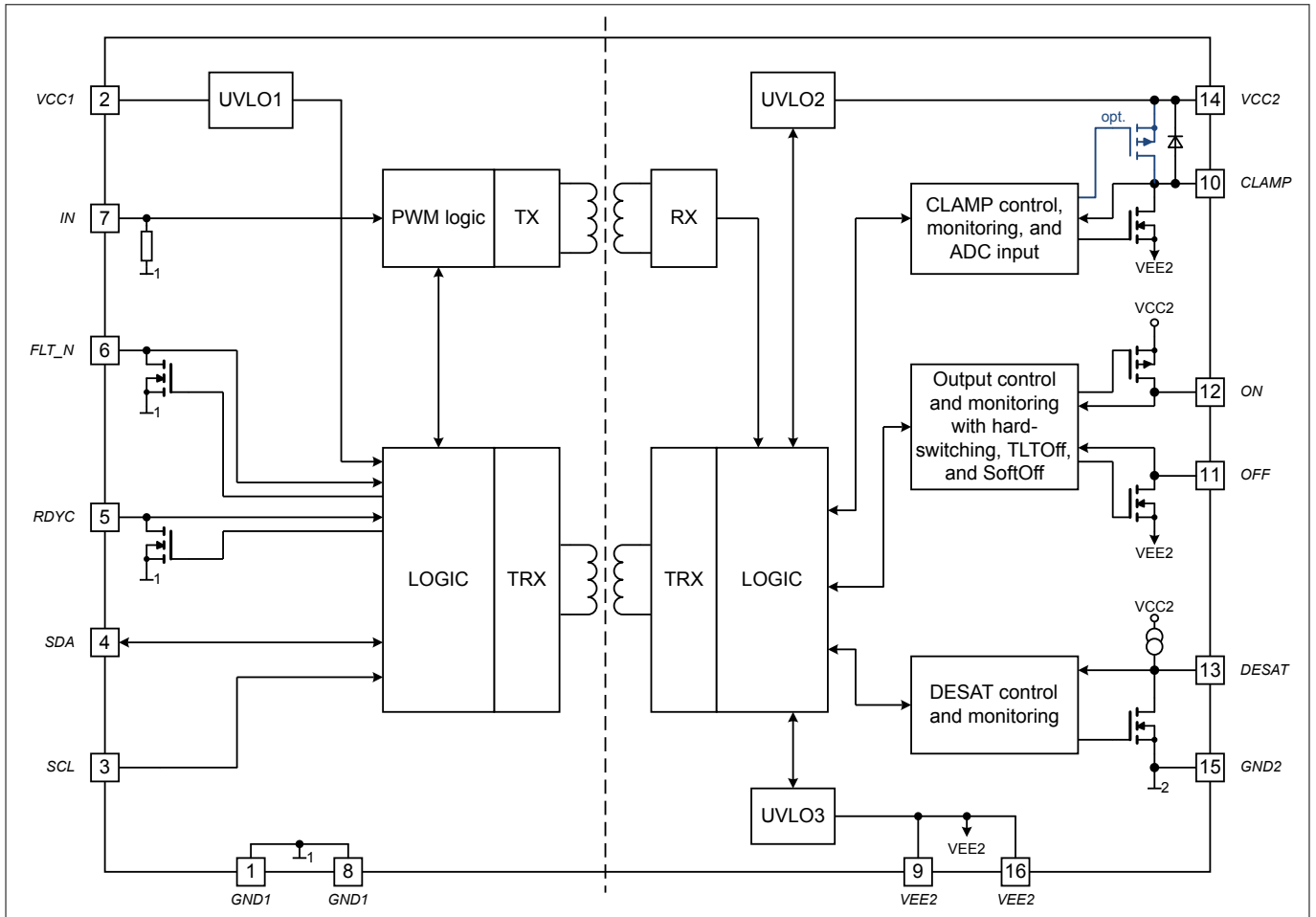


Figure 2 Block diagram

**2 Related products**

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*Note: Please consider the gate driver IC power dissipation and insulation requirements for the selected power switch and operating condition.*

<b>Product group</b>	<b>Product name</b>	<b>Description</b>
TRENCHSTOP™ IGBT Discrete	<a href="#">IKQ75N120CS6</a>	High Speed 1200 V, 75 A IGBT with anti-parallel diode in TO247-3
	<a href="#">IKW15N120BH6</a>	High Speed 1200 V, 15 A IGBT with anti-parallel diode in TO247
	<a href="#">IHW40N120R5</a>	Reverse conducting 1200 V, 40 A IH IGBT with integrated diode in TO247
CoolSiC™ SiC MOSFET Discrete	<a href="#">IMBF170R650M1</a>	1700 V, 650 mΩ SiC MOSFET in TO263-7 package
	<a href="#">IMBG120R045M1H</a>	1200 V, 45 mΩ SiC MOSFET in TO263-7 package
	<a href="#">IMZ120R350M1H</a>	1200 V, 350 mΩ SiC MOSFET in TO247-4 package
CoolSiC™ SiC MOSFET Module	<a href="#">FS45MR12W1M1_B11</a>	EasyPACK™ 1B 1200 V / 45 mΩ sixpack module
	<a href="#">FF23MR12W1M1_B11</a>	EasyDUAL™ 1B 1200 V, 23 mΩ half-bridge module
	<a href="#">FF6MR12W2M1_B11</a>	EasyDUAL™ 2B 1200 V, 6 mΩ half-bridge module
	<a href="#">F3L11MR12W2M1_B74</a>	EasyPACK™ 2B 1200 V, 11 mΩ 3-Level module in Advanced NPC (ANPC) topology
	<a href="#">F4-23MR12W1M1_B11</a>	EasyPACK™ 1B 1200 V, 23 mΩ fourpack module
TRENCHSTOP™ IGBT Modules	<a href="#">F4-100R17N3E4</a>	EconoPACK™ 3 1700 V, 100 A fourpack IGBT module
	<a href="#">F4-200R17N3E4</a>	EconoPACK™ 3 1700 V, 200 A fourpack IGBT module
	<a href="#">FS150R17N3E4</a>	EconoPACK™ 3 1700 V, 150 A sixpack IGBT module
	<a href="#">FF650R17IE4</a>	PrimePACK™ 3 1700 V, 650 A half-bridge dual IGBT module
	<a href="#">FF1000R17IE4</a>	PrimePACK™ 3 1700 V, 1000 A half-bridge dual IGBT module
	<a href="#">FF1200R17IP5</a>	PrimePACK™ 3+ 1700 V, 1200 A dual IGBT module
	<a href="#">FF1500R17IP5</a>	PrimePACK™ 3+ 1700 V, 1500 A dual IGBT module
	<a href="#">FF1500R17IP5R</a>	PrimePACK™ 3 1700 V, 1500 A dual IGBT module
	<a href="#">FF1800R17IP5</a>	PrimePACK™ 3+ 1700 V, 1800 A dual IGBT module
	<a href="#">FP10R12W1T7_B11</a>	EasyPIM™ 1B 1200 V, 10 A three phase input rectifier PIM IGBT module
	<a href="#">FS100R12W2T7_B11</a>	EasyPACK™ 2B 1200 V, 100 A sixpack IGBT module
	<a href="#">FP150R12KT4_B11</a>	EconoPIM™ 3 1200V three-phase PIM IGBT module
	<a href="#">FS200R12KT4R_B11</a>	EconoPACK™ 3 1200 V, 200 A sixpack IGBT module

**3 Pin configuration and functionality**

**3 Pin configuration and functionality**

The pin assignment at the gate driver IC generally differentiates between the input side and the output side.

**Table 1 General pin assignment**

Pins	Designation
1 to 8	input side, input logic signal side, or low voltage side
9 to 16	output side, driver power side, or high voltage side

For simplicity reasons the driver is described as an IGBT driver. For use with MOSFETs and other power switches simply replace any mentioning of collector and emitter with their corresponding pin names.

**3.1 Pin configuration**

**Table 2 Pin configuration table abbreviations**

Abbreviation	Description
Pin type	
<b>PWR</b>	Power supply and gate current output pins
<b>I/O</b>	Digital input and output pin
<b>I</b>	Digital input pin
<b>GND</b>	Ground reference pin
<b>AI</b>	Analog input pin
Buffer type	
<b>OD</b>	Open drain output
<b>CMOS</b>	CMOS compatible input threshold levels
<b>PP</b>	Push/pull output buffer
<b>analog</b>	Analog input buffer
<b>special</b>	Special output/input function, see individual description
Pull device	
<b>PD</b>	Pull-down resistor
<b>CS</b>	Current source

**Table 3 Pin configuration**

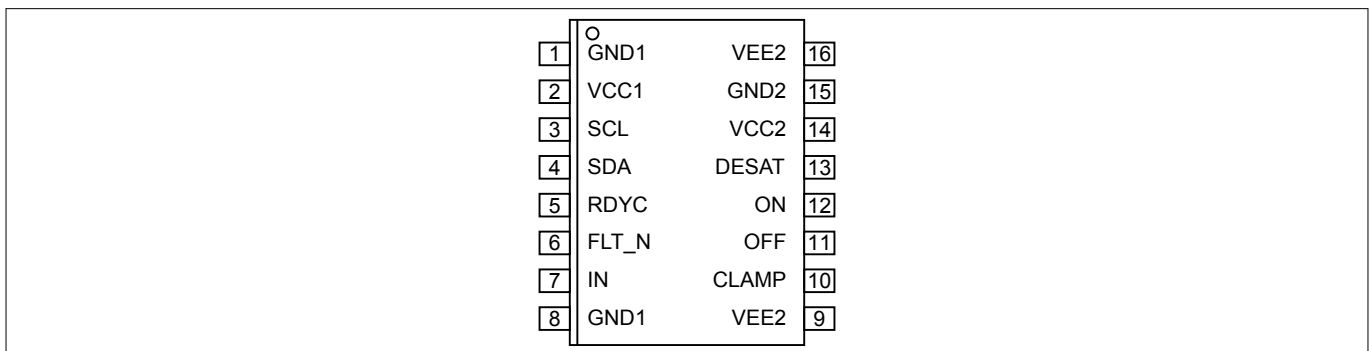
Pin no.	Pin name	Pin type	Buffer type	Pull device	Function
1	<i>GND1</i>	GND	–	–	Ground input side
2	<i>VCC1</i>	PWR	–	–	Positive power supply input side
3	<i>SCL</i>	I	CMOS	–	Clock input of serial I2C bus
4	<i>SDA</i>	I/O	OD, CMOS	–	Data I/O of serial I2C bus
5	<i>RDYC</i>	I/O	OD, CMOS	–	Combined ready output, high active and fault clear input and soft-off input, low active
6	<i>FLT_N</i>	I/O	OD, CMOS	–	Fault output, low active and soft-off input, low active

**(table continues...)**

**3 Pin configuration and functionality**

**Table 3 (continued) Pin configuration**

Pin no.	Pin name	Pin type	Buffer type	Pull device	Function
7	IN	I	CMOS	PD, 40 kΩ	Non inverted driver input
8	GND1	GND	–	–	Ground input side
9	VEE2	GND	–	–	Negative power supply output side
10	CLAMP	PWR, AI	OD, PP, analog	–	Active Miller clamping with open drain to VEE2, clamp driver for external MOSFET, or ADC input
11	OFF	PWR, AI	OD	–	Driver sink output
12	ON	PWR, AI	OD	–	Driver source output
13	DESAT	AI	special	CS, 500 μA	Enhanced desaturation protection
14	VCC2	PWR	–	–	Positive power supply output side
15	GND2	AI	–	–	Signal ground output side
16	VEE2	GND	–	–	Negative power supply output side



**Figure 3 PG-DSO-16 (top view)**

**3.2 Pin functionality**

**GND1**

Reference ground of the input side. Connect direct to input signal ground.

**VCC1**

Positive power supply terminal of the input side, connect to 5 V or 3.3 V for proper operation. Place a decoupling capacitor close to this pin and *GND1*.

**SCL and SDA serial bus connection**

Serial data I/O and clock input pin of the I2C bus. Connect to a microcontroller with 5 V or 3.3 V I/O and add a pull-up resistor to positive supply voltage *VCC1*. Signals *SCL* and *SDA* are referenced to *GND1*.

**RDYC ready status output, fault-off input and fault-clear input**

Open-drain output reports the correct operation of the device, ready output is high active. Fault-clear input and fault-off input clears a gate driver fault or switch the gate driver output to off with fault-off function, input is low active. Connect to a microcontroller with 5 V or 3.3 V I/O with an external pull-up resistor to *VCC1*. A typical value for this resistor is 2.2 kΩ. The *RDCY* signal is referenced to *GND1*.



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### 3 Pin configuration and functionality

#### **FLT\_N fault output and fault-off input**

Open-drain output reports the failures related to operating of the inverter system to the microcontroller, fault output is active low. Fault-off input switch the gate driver output to off with fault-off function, input is low active. Connect to a microcontroller with 5 V or 3.3 V I/O with an external pull-up resistor to *VCC1*. A typical value for this resistor is 2.2 kΩ. The *FLT\_N* signal is referenced to *GND1*.

#### **IN non inverting gate driver input**

*IN* input controls the output of the gate driver IC, the IGBT is turned on if *IN* is set to high. Connect to a PWM output of the microcontroller with 5 V or 3.3 V IO. An internal pull-down resistor ensures IGBT off-state if not connected.

#### **VEE2**

Negative power supply terminal of the output side. Connect to a voltage of 0 V to -25 V referenced to *GND2* for proper operation. Place a decoupling capacitor close to the following pins:

- *VCC2* and *VEE2*
- *GND2* and *VEE2*

If no negative supply voltage is used, all *VEE2* pins have to be connected to *GND2*.

#### **CLAMP Miller clamp output, Miller clamp pre-driver output, ADC input**

The function and operating mode of this pin is depending on the register configuration.

High-current clamp output to hold the gate voltage low during collector-emitter-voltage rise. Connect directly to the gate of the IGBT.

Clamp pre-driver output for the use of an external clamp switch. Connect directly to the gate of a n-channel MOSFET.

Sensing input for 8-bit ADC. Connect the external signal source between *CLAMP* and *VEE2*.

#### **OFF driver output**

High-current driver sink output to discharge the gate of the external IGBT and the optional two-level turn-off control output. The gate driver IC also sinks the Soft-off current at this pin. The pin is used as sense input for the gate high-level indicator **PINSTAT.OFF\_PIN** and TLTOFF comparator **PINSTAT.TLTO\_LVL**. Connect to the gate of the IGBT via a chosen turn-off gate resistor.

#### **ON driver output**

High-current driver source output to charge the gate of the external IGBT and turn it on and sense input for the CLAMP function. It is also the sense input for the gate low-level indicator **PINSTAT.ON\_PIN**. Connect to the gate of the IGBT via a chosen turn-on gate resistor.

#### **DESAT enhanced desaturation detection input**

Desaturation detection input to monitor the IGBT collector-emitter voltage ( $V_{CE}$ ) to detect desaturation caused by short circuit events. Connect to the collector of the driven IGBT via a series connection of a protection resistor and a high-voltage diode. The *DESAT* signal is referenced to *GND2*.

#### **VCC2**

Positive power supply terminal of the output side. Connect to sufficient supply voltage referenced to *GND2* for proper operation. Place a decoupling capacitor close to the following pins:

- *VCC2* and *VEE2*
- *VCC2* and *GND2*

**3 Pin configuration and functionality**

**GND2 reference ground**

Reference ground of the output side. Connect to common voltage of a bipolar supply and the emitter of the IGBT. Place a decoupling capacitor close to the following pins:

- VCC2 and GND2
- GND2 and VEE2

**3.3 Configurable parameters via I2C**

The following parameters are fully configurable via the I2C interface. The default behavior describes the gate driver configuration if only the address configuration has been set before writing **CFGOK.USER\_OK** to 1<sub>B</sub>.

**Table 4 Configurability via I2C**

	<b>Adjustable parameter</b>	<b>Default behavior/value</b>
UVLO	VCC2-GND2 turn-on UVLO (max)	12.6 V
	VEE2-GND2 UVLO (n.a./-3.5/-6/-12.0 V)	Not active
Output drive	CLAMP pin mode (3 A, pre-driver, or ADC)	3 A sink only
	Filter time for CLAMP and pin status monitoring	235 ns
	CLAMP and switch on filter type	Up-reset
	Two-level turn-off	Hard switch-off A = 30 V/ns; 9.0 V; 2.0 μs; B = hard switch-off
	Soft-off current (set as default fault-off method)	<b>CSSOFFCFG.CSSOFF_I</b> =9 <sub>D</sub> , 1ED3830M: 146 mA, 1ED3860M: 291 mA, 1ED3890M: 437 mA
	Driver input filter length	103 ns
DESAT	DESAT1 threshold voltage	9.18 V
	Leading edge blanking time	400 ns
	DESAT1 filter time	225 ns
	DESAT1 filter type	Up-reset
	DESAT2 threshold, filter, and action configuration	Disabled
Fault/fault clear	Fault clear source (RDYC or self clear time)	RDYC
	Self clear time (not active, 400 μs, 1600 μs)	Not active
	Fault-off mode (hard switch-off, soft-off, TLTOff)	Hard switch-off
	Over-temperature warning action (warning or fault off)	Warning
	Over-temperature warning level	140°C

## 4 Functional description

### 4 Functional description

The 1ED38x0Mc12M family (X3 Digital) consists of galvanically isolated single channel gate driver ICs with an extensive digital adjustable feature parameter set. All adjustments are done from low voltage input side during start up via I2C bus. The configuration is stored into registers.

To start-up the gate driver IC for normal operation both input and output sides of the gate driver IC need to be powered.

The 1ED38x0Mc12M family (X3 Digital) is designed to support various supply configurations on the input and output side. On the output side unipolar and bipolar supply is possible.

The output stage is realized as rail-to-rail. There the gate driver voltage follows the supply voltage without an additional voltage drop. In addition it provides an easy clamping of the gate voltage during short circuit of an external IGBT.

The *RDYC* status output reports correct operation of the gate driver IC like sufficient voltage supply. The *FLT\_N* status output reports failures in the application like desaturation detection.

To ensure safe operation the gate driver IC is equipped with an input and output side under-voltage lockout circuit. The UVLO levels are optimized for IGBTs and MOSFETs, and are adjustable.

The desaturation detection circuit protects the external IGBT from destruction at a short circuit. The gate driver IC reacts on a DESAT fault by turning off the IGBT with one of the following configurable turn-off methods:

- two-level turn-off
- adjustable soft-off
- hard switch-off

The two-level turn-off (TLTOff) is a voltage controlled turn-off function.

The soft turn-off function is used to switch-off the external IGBT in overcurrent conditions in a soft-controlled manner to protect the IGBT against collector emitter over-voltages.

An adjustable active Miller clamp function protects the IGBT from parasitic turn-on in fast switching applications.

The 1ED38x0 family also offers several measurement and monitoring functions. The monitoring functions can be divided into:

- hardware based functions and
- ADC measurement based functions.

*Note:* Please refer to the reference manual of this product for a detailed functional description. This chapter does not provide all the information required to fully operate the product.

#### 4.1 Start-up and fault clearing

For normal operation both input and output sides of the gate driver IC need to be powered. A low level at the *FLT\_N* pin always indicates a fault condition. In this case the IC starts internal mechanisms for fault clearing.

##### Input side start-up

1. Voltage at *VCC1* reaches the input UVLO threshold: input side of gate driver IC starts operating
2. *FLT\_N* follows input supply voltage
3. Input side is ready to communicate across I2C bus, awaiting user gate driver parameter configuration
4. Records parameters received across the I2C bus
5. Waits until output side is powered
6. Initiates internal start-up: Transfers configured values to output side
7. Performs internal self-test

The complete start-up time  $t_{START1}$  depends on the duration of the user parameter configuration.

## 4 Functional description

### Output side start-up

1. Voltage at  $VCC2$  reaches the output UVLO threshold: output side of gate driver IC starts operating
2. Activates OFF gate driver output: connected gate stays discharged
3. Waits until input side is powered
4. Initiates internal start-up: Receives configured values from input side
5. Performs internal self-test

The complete start-up time  $t_{START2}$  depends on the duration of the user parameter configuration.

The gate driver IC releases  $RDYC$  to high to signal a successful start-up and its readiness to operate. The gate driver IC will follow the status of the  $IN$  signal.

### Clearing a fault with $RDYC$ to low cycle

1. Set  $IN$  to low
2. Set  $RDYC$  to low for a duration longer than the fault clear time  $t_{CLRMIN}$
3. Release  $RDYC$  to high
  - a. If the source of the fault is no longer present,  $FLT\_N$  is released to high
  - b. If another fault source is active,  $FLT\_N$  stays low and the cycle needs to be repeated
4. Continue PWM operation

### Clearing a fault by self clear timer

1. Set  $IN$  to low
2. Self clear timer starts counting
3. Self clear timer reaches self clear time
  - a. If the source of the fault is no longer present,  $FLT\_N$  is released to high
  - b. If another fault source is active,  $FLT\_N$  stays low and the timer restarts
4. Continue PWM operation

## 4.2 Supply

The 1ED38x0Mc12M family (X3 Digital) is designed to support various supply configurations. The input side can be used with a 3.3 V or 5 V supply.

The output side requires either an unipolar supply ( $VEE2 = GND2$ ) or a bipolar supply.

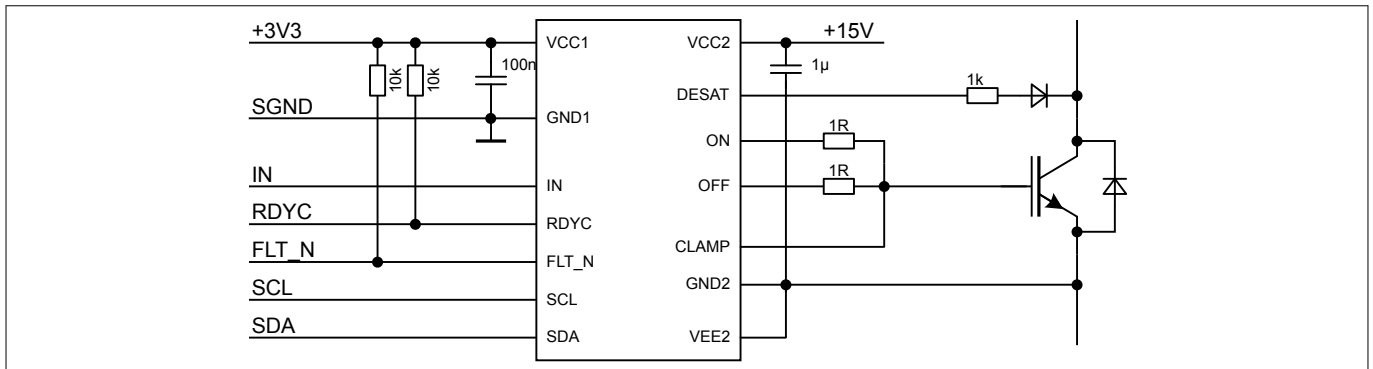
- Individual supply voltages between  $VCC2$  and  $GND2$  or  $GND2$  and  $VEE2$  shall not exceed 25 V.
- The total supply voltage between  $VCC2$  and  $VEE2$  shall not exceed 35 V.

To ensure safe operation of the gate driver IC, it is equipped with an input and output side undervoltage lockout circuit.

### Unipolar supply

In unipolar supply configuration the gate driver IC is typically supplied with a positive voltage of 15 V at  $VCC2$ .  $GND2$  and  $VEE2$  are connected together and this common potential is connected to the IGBT emitter.

**4 Functional description**

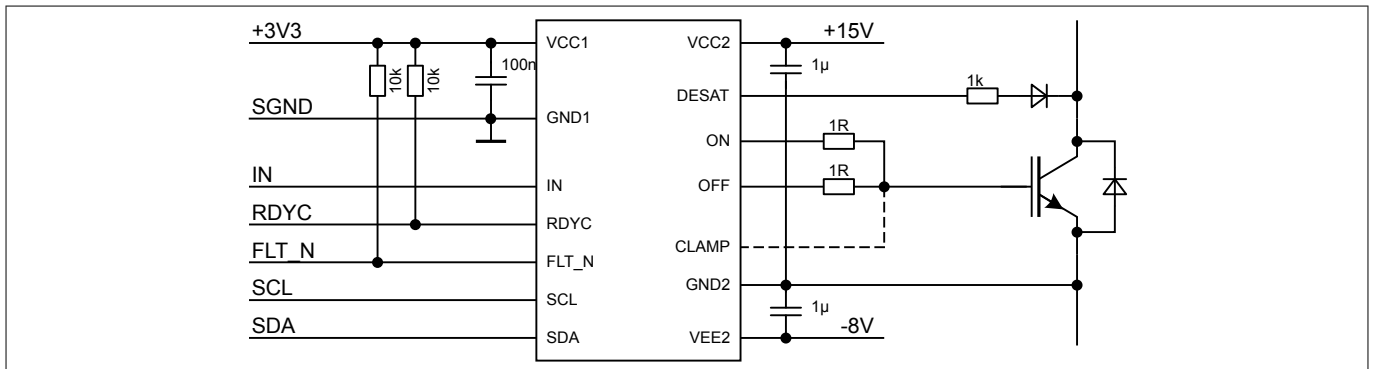


**Figure 4 Application example with unipolar supply**

**Bipolar supply**

For bipolar supply the gate driver IC is typically supplied with a positive voltage of 15 V at *VCC2* and a negative voltage of -8 V or -15 V at *VEE2* relative to *GND2*.

Between *VCC2* and *VEE2* the maximum potential difference is 35 V.



**Figure 5 Application example with bipolar supply**

Negative supply prevents a parasitic turn-on due to the additional voltage margin to the gate turn-on threshold.

**VEE2 over GND2 supply connection check**

The gate driver IC has a built-in connection check for *VEE2*. A loss of *VEE2* connection will be detected and signaled via *RDYC*.

**4.3 Input side logic**

The input threshold levels are always CMOS compliant. The threshold levels are 30% of *VCC1* for low level and 70% of *VCC1* for high level.

The pins *IN* and *SCL* are for input only, and the pins *SDA*, *FLT\_N*, and *RDYC* are input/output pins.

**4.4 I2C bus**

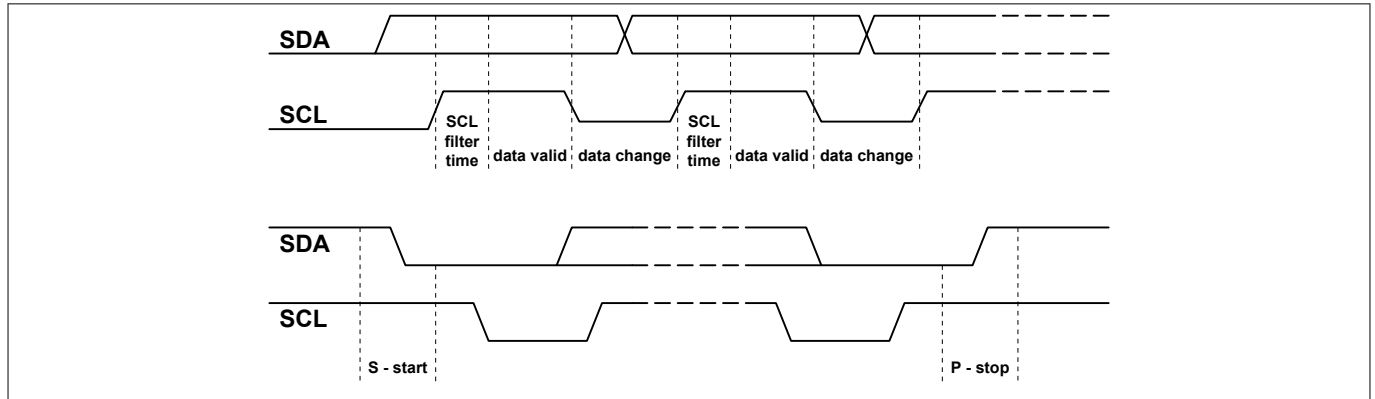
The 1ED38x0 family is equipped with a standard I2C bus interface to configure various parameters of the gate driver IC and read out measurement and monitoring registers.

Key I2C features include:

- I2C bus slave device implementing all mandatory slave bus protocols for the specification [UM10204 rev. 6](#)
- 7 bit device addresses for individual and group addressing
- Initial I2C device address: 1A<sub>H</sub> (MSB aligned, bits 7:1)

#### 4 Functional description

- Signal voltage level compatible to 3.3 V and 5 V
- Supported bus speeds at gate driver data pin (*SDA*) and clock pin (*SCL*):
  - standard-mode (*Sm*), with bit rates up to 100 kbit/s
  - fast-mode (*Fm*), with bit rates up to 400 kbit/s
  - fast-mode plus (*FM+*), with bit rates up to 1 Mbit/s



**Figure 6 Start, stop and data conditions**

All I2C bus commands start with a start condition and stops with a stop condition. The data at the *SDA* pin gets valid if *SCL* level is above the CMOS level threshold and the filter time has elapsed.

4 Functional description

4.5 Operating states

The 1ED38x0 family of gate driver ICs can take the following states:

- OFF state, device not powered
- Address configuration state, the I2C addresses can be set, gate driver IC is not active
- Parameter configuration state, the gate driver parameters can be set and changed, gate driver IC is not active
- Parameter transfer state, the gate driver IC is transferring the parameters from input side to output side, gate driver IC is not active
- Normal operation, gate driver IC is active, ON and OFF outputs are following the IN signal, registers are read only
- Not ready state, gate driver IC is switched off according to fault off settings, status signaled by a low at RDYC pin
- Fault state, gate driver IC is switched off according to fault off settings, status signaled by a low at FLT\_N pin
- See later section for additional sub states on fault clear, soft-reset, recover, and restore of parameter configuration after power loss

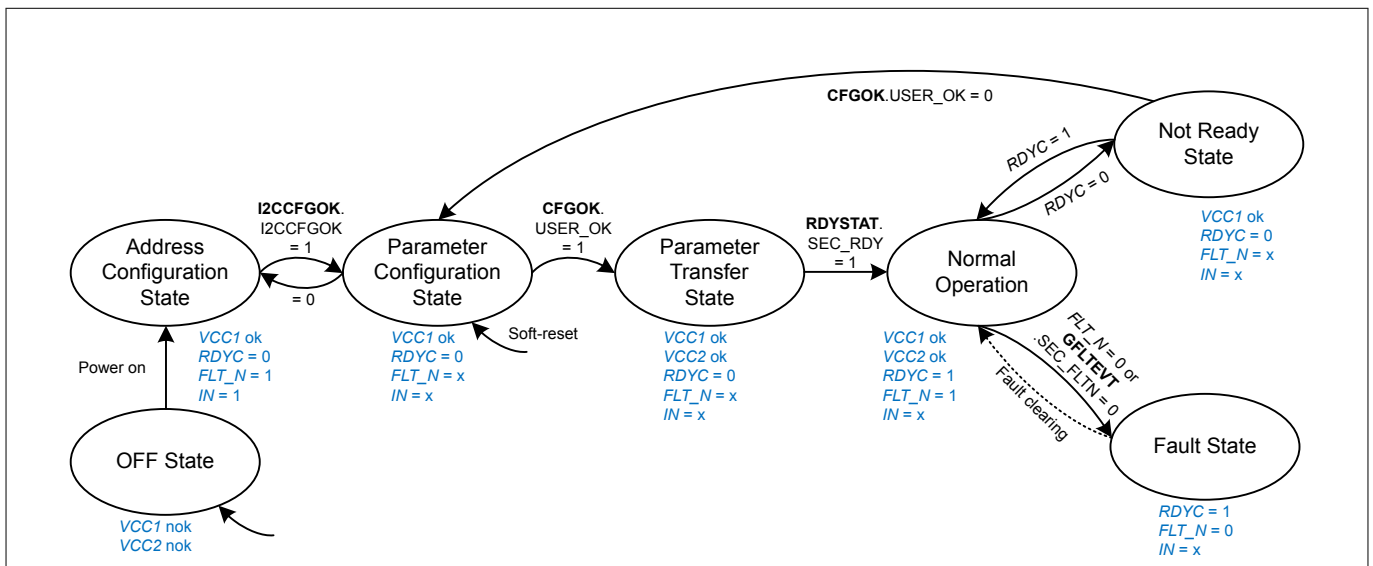


Figure 7 Operating state diagram

- Pin names in uppercase italic letters, supply pin status listed as either okay (ok) or not okay (nok) and for logic pins with low (0), high (1), or either (x)
- Register names in uppercase bold letters followed by the register bit name and value
- States in bubbles with transitions marked by arrows with conditions attached

4.6 Measurement

The 1ED38x0 family offers several measurement functions and uses a free running successive-approximation-register analog-to-digital converter (SAR-ADC). The SAR-ADC has a 8 bit resolution and the results are digitally filtered with a three-point-two pass moving average filter.

Following internal and external parameter measurements are available:

- **ADCMVCC2** Measurement VCC2 to VEE2
- **ADCMVDIF** Measurement and calculation VCC2 to GND2
- **ADCMGND2** Measurement GND2 to VEE2

## 4 Functional description

- **ADCMTEMP** Measurement junction temperature  $T_J$
- **ADCMVEXT** Measurement external voltages, e.g. NTC

Measurement result registers will be updated sequentially depending on selected sample sources. The update rate is typically below 100  $\mu$ s.

The SAR-ADC configuration register **ADCCFG** is used to activate measurement channels and external voltage compare behavior. Measurement of internal junction temperature is always active. Activated SAR-ADC measurements also enable monitoring functions.

### 4.7 Monitoring

The 1ED38x0 family offers many monitoring functions. The monitoring functions can be divided into:

- Hardware based functions

The hardware based monitoring functions use dedicated hardware, e.g. fast UVLO.

- ADC-based functions

The ADC-based functions gather measured values of different parameters and compare them with limit values. Enable ADC measurement to use related ADC-based monitoring functions.

Both groups contain non-configurable and configurable functions.

Non-configurable hardware monitoring:

- *VEE2* over *GND2*, e.g. *VEE2* connection failure
- Turn-off monitoring,  $V_{ON} > VEE2+2$  V (**FLTEVT.VOUST** = 1<sub>B</sub>)
- Gate voltage monitoring below  $VEE2+2$  V (**PINSTAT.ON\_PIN** = 1<sub>B</sub>)
- Gate voltage monitoring above  $VCC2-2$  V (**PINSTAT.OFF\_PIN** = 1<sub>B</sub>)
- Gate voltage monitoring above  $V_{TLTOFF}$  (**PINSTAT.TLTO\_LVL** = 1<sub>B</sub>)
- Pin status monitoring of *IN* pin high (**PINSTAT.PWM\_IN** = 1<sub>B</sub>)
- Pin status monitoring of *RDYC* pin high (**PINSTAT.RDYC** = 1<sub>B</sub>)
- Pin status monitoring of *FLT\_N* pin high (**PINSTAT.FLT\_N** = 1<sub>B</sub>)
- *VCC1* supply voltage UVLO spike detection (**UV1FCNT**)
- *VCC2* supply voltage UVLO spike detection (**UV2FCNT**)

Configurable hardware monitoring:

- Normal *VCC2* supply UVLO event (**SECUVEVT.UV\_VCC2**)
- Normal *VEE2* supply UVLO event (**SECUVEVT.UV\_VEE2**)
- Switch-off timeout,  $V_{ON} > VEE2+2$  V and maximal switch-off timeout time elapsed (**FLTEVT.SOTO\_EVT**)

Non-configurable ADC-based monitoring:

- Over temperature protection event (**FLTEVT.OTP\_EVT**)

Configurable ADC-based monitoring:

- *VCC2* supply soft UVLO event (**SECUVEVT.UVSVCC2**)
- *VEE2* supply soft UVLO event (**SECUVEVT.UVSVEE2**)
- External voltage compare event (**FLTEVT.VEXTFLT**)
- Over temperature warning event (**FLTEVT.OTW\_EVT**)

#### Gate driver reaction to *VEE2* over *GND2* detected

A *VEE2* over *GND2* event triggers the following sequence:

1. IC detects *VEE2* over *GND2*
2. IC initiates an output side reset, including
  - Activation of active shutdown as a safety measure



#### **4 Functional description**

- Resetting all configuration registers to their reset values
  - Ignoring all PWM signals and reporting a not ready state
- 3.** IC listens to its previously configured I2C address
- If **RECOVER.RESTORE** = 1<sub>B</sub>, the gate driver IC will restore the output side configuration from the input side
  - If **RECOVER.RESTORE** = 0<sub>B</sub>, the gate driver IC performs a soft-reset and waits for a re-configuration via I2C bus
- 4.** After the configuration of the output side is valid again, the IC continues operation

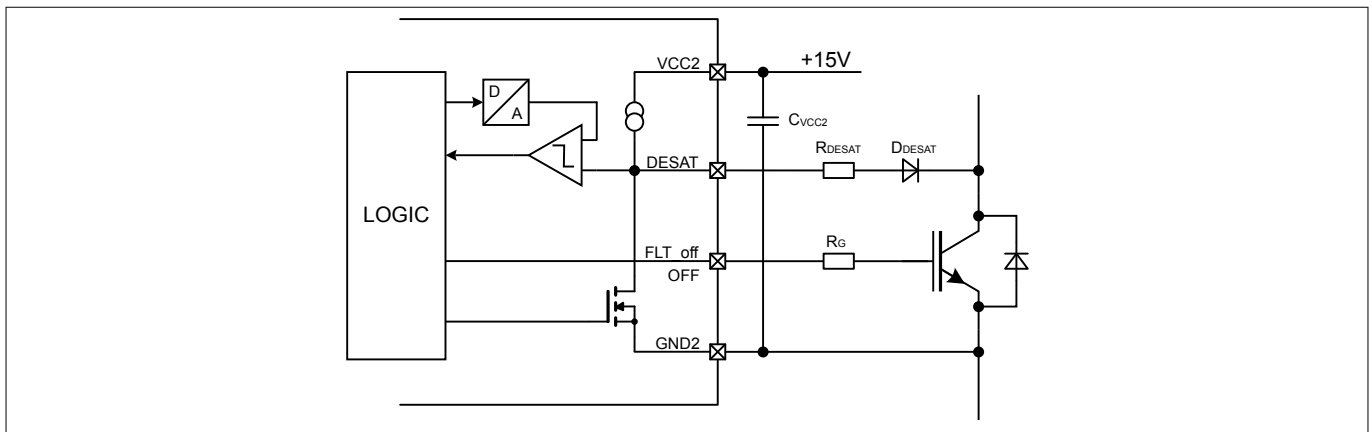
*Note: To avoid unintended VEE2 over GND2 detection, take extra care in power supply design, routing, and capacitive blocking at these pins.*

**4 Functional description**

**4.8 Desaturation protection**

The desaturation detection circuit protects the external IGBT from destruction at a short circuit. The desaturation protection follows the given sequence:

1. Voltage at *DESAT* pin reaches DESAT threshold level, e.g. 9.18 V, for a period of time exceeding the filter time
2. Gate driver IC output switches the external IGBT off, using the defined fault off method
3. Gate driver IC switches *FLT\_N* pin to low to indicate the fault to a connected microcontroller
4. Short circuit situation is resolved
  - after the voltage at the *ON* pin has dropped below the  $V_{EE2}+2$  V threshold,
  - no other fault condition is present,
  - the input has been turned off and
  - the fault has been cleared using the defined fault clear method



**Figure 8 DESAT circuit (only relevant pins shown)**

The high-precision internal current source results in a minimum impact on the DESAT detection variation.

**4.8.1 DESAT behavior**

The DESAT function offers a leading edge blanking time and filters to optimize the DESAT detection for application usage.

The leading edge blanking inhibits threshold detection during an IGBT turn on phase. The typical IGBT turn on behavior starts with charging of the gate, commutation of the application load current and finally  $V_{CE}$  voltage decrease to  $V_{CEsat}$  voltage levels. To prevent the gate driver IC from detecting a false DESAT event, leading edge blanking pauses the DESAT circuit until the time  $t_{DESATleb}$  has elapsed.

Following the leading edge blanking time, the gate driver IC forces the DESAT current into the external DESAT circuit. The current typically flows through a protection resistor, a fast high voltage diode and the collector-emitter path of the IGBT. The resulting voltage at the *DESAT* pin is the sum of the voltage drop across this path.

During a short circuit condition, the  $V_{CE}$  voltage increases, resulting in a reverse polarity condition of the DESAT diode. The remaining DESAT current also increases the voltage level at the *DESAT* pin and triggers the DESAT threshold. If the pin voltage level stays above the threshold for the duration of the DESAT filter time  $t_{DESATfilter}$ , the gate driver IC registers the DESAT event and acts accordingly.

The internal processing time after DESAT threshold crossing, filtering and beginning of fault-off is defined as  $t_{DESATOUT}$ . The duration of the gate discharge during fault-off is defined as  $t_{FLTOFFtot}$  and is depending on the defined fault off function and the gate load.

4 Functional description

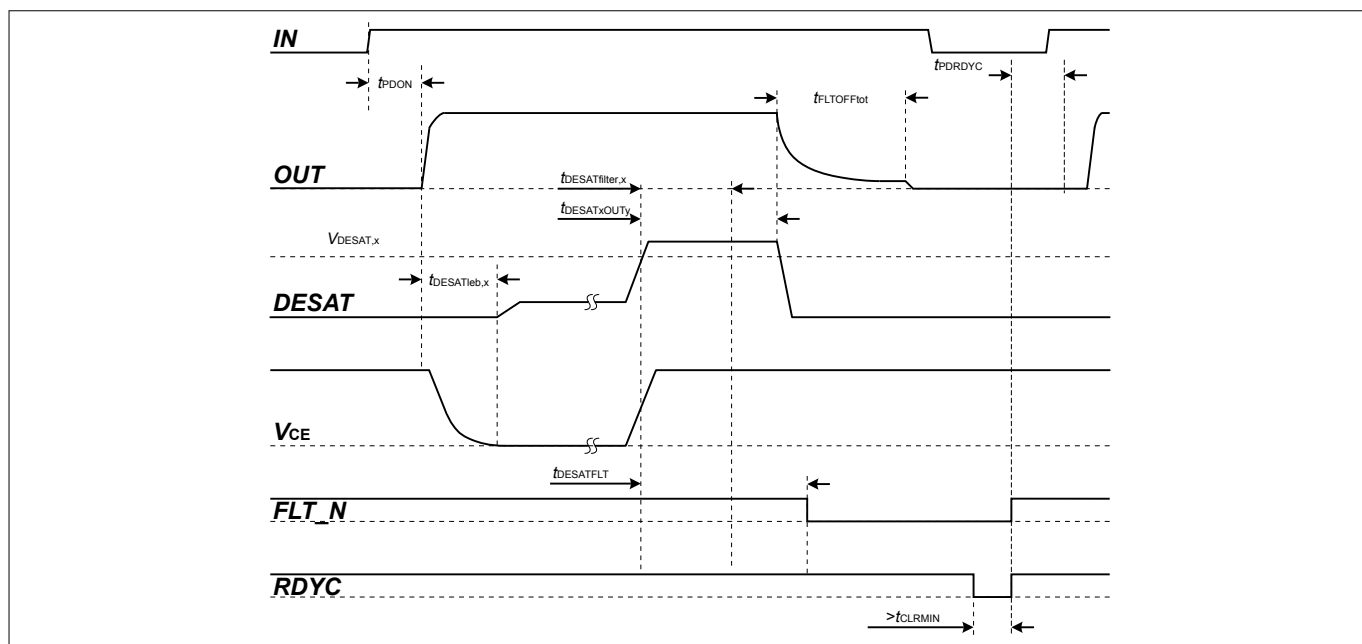


Figure 9 DESAT timing with leading edge blanking, filter and reaction times

**4 Functional description**

**4.9 Gate driver output**

The gate driver output side uses MOSFETs to provide a rail-to-rail output. Therefore, the gate drive voltage follows the supply voltage closely.

Due to the low internal voltage drop, the switching behavior of the IGBT is predominantly governed by the external gate resistor. The gate driver IC offers separate sink and source outputs to adapt the gate resistor for turn-on and turn-off separately without additional bypass components.

The cell value x in the following table is placeholder for high or low and indicates that this pin does not influence the resulting gate driver output state. The arrow (→) in cells indicate the transition initiated by the pin of the logic input and gate driver supply pins resulting in a transition to the gate driver output state as listed.

**Table 5 Driver output state including transition behavior**

Logic input and gate driver supply					Gate driver output	
<i>IN</i>	<i>RDYC</i>	<i>FLT_N</i>	<i>VCC1</i>	<i>VCC2</i>	<i>ON</i>	<i>OFF</i>
Static gate driver output state: on and off						
high	high	high	high	high	high	tri-state
low	high	high	high	high	tri-state	low
Transition to not ready and static not ready state						
x	high → low	high	high	high	→ tri-state	→ fault off
x	low	high	high	high	tri-state	low
Transition to fault and static fault state						
x	high	high → low	high	high	→ tri-state	→ fault off
x	high	low	high	high	tri-state	low
Transition with VCC1 power loss and unsupplied input side						
x	x	x	high → low	high	→ tri-state	→ fault off
x	x	x	low	high	tri-state	low
Transition with VCC2 power loss and unsupplied output side						
x	x	x	x	high → low	→ tri-state	→ fault off
x	x	x	x	low	tri-state	active shut down

4 Functional description

4.9.1 Turn-on behavior

The 1ED38x0Mc12M family (X3 Digital) is optimized for hard switching turn-on. A turn-on command switches the ON pin internally to VCC2.

4.9.2 Turn-off and fault turn-off behavior

The gate driver IC supports different turn-off sequences to adapt to different applications and IGBT currents during normal switching operation and in the case of a fault.

Table 6 Turn-off sequences

Turn-off reason	Turn-off sequence			Remark
	Hard switching	Two-level turn-off	Soft turn-off	
normal off	X	X		adjustable
fault turn-off	X	X	X	adjustable

The gate driver turn-off behavior can be configured in register **DRVCFG.STD\_OFF**.

The gate driver fault turn-off behavior can be configured in register **DRVFOFF.DRV\_FOFF**.

In some topologies the fault turn-off needs to be delayed for individual switch positions. The fault turn-off delay time  $t_{FAULTOFFn}$  is adjustable in the register **F2ODLY.F2O\_DLY**.

The gate driver monitors the gate voltage and sets the register bit **FLTEVT.VOUT\_ST** to 1<sub>B</sub> as long as the voltage at the ON pin is above  $VEE2 + 2 V$ .

Once started, the fault turn-off sequence cannot be interrupted by an  $IN = \text{low}$  turn-off signal.

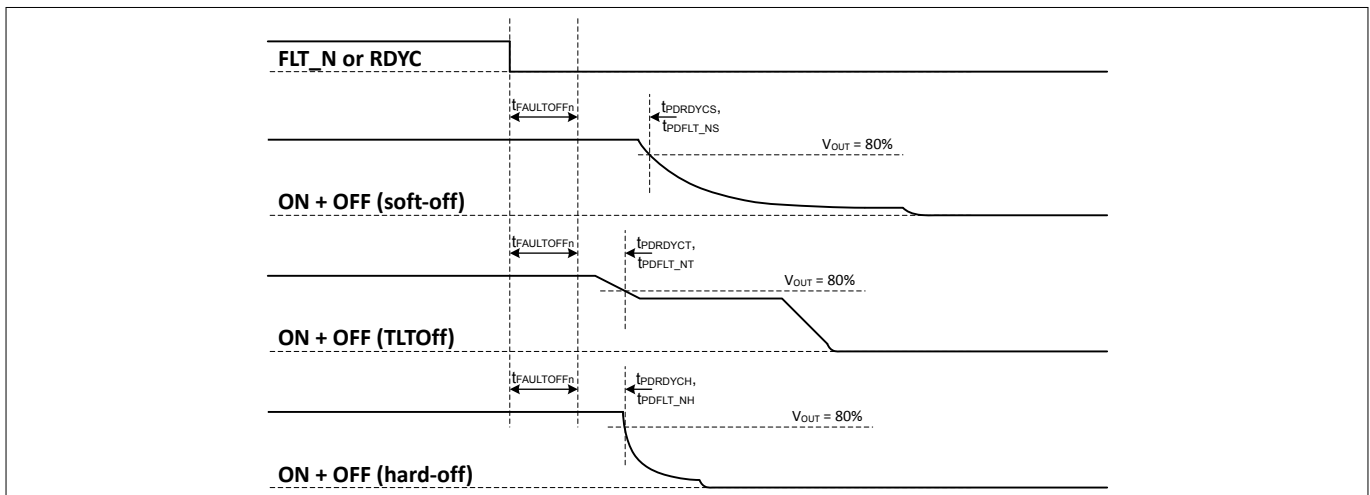


Figure 10 Fault turn-off sequence initiated by FLT\_N or RDYC

4 Functional description

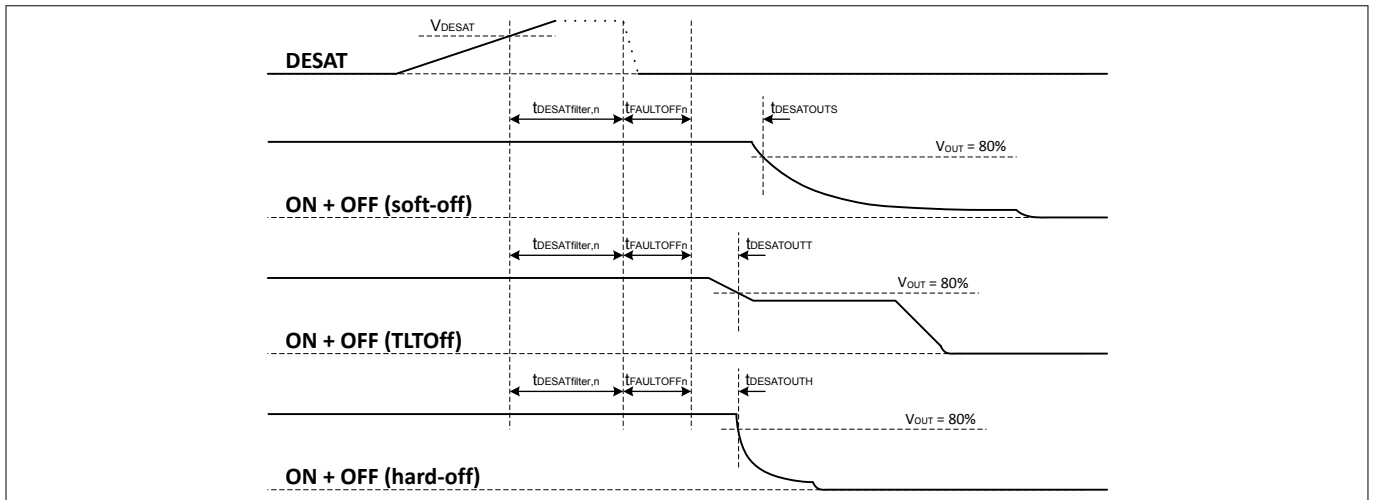


Figure 11 Fault turn-off sequence initiated by DESAT event

4.9.2.1 Hard switching turn-off

Hard switching turn-off supports fast switching applications and applications with emitter-follower booster stages. The switching behavior of the IGBT is controlled by adjusting the external gate resistance between the OFF pin and the IGBT gate.

4.9.2.2 Two-level turn-off

The two-level turn-off (TLTOff) is a voltage controlled turn-off function.

Two-level turn-off supports secure IGBT turn-off even under overload conditions with low  $V_{CE}$  overshoot. It also operates in applications with emitter-follower booster stages, typical for high power applications with larger  $di/dt$ . With two-level turn-off the switching behavior of the IGBT is controlled by the plateau voltage and the ramp speed.

The gate driver IC is switching the IGBT gate off by discharging from positive supply to an intermediate voltage level plateau to reduce a collector over current and continued turn-off thereafter. In detail this includes:

1. Discharge gate from  $V_{CC2}$  voltage level to intermediate voltage level with the controlled voltage ramp A.
2. At the intermediate gate voltage level the IGBT collector current is being limited at overload application conditions.
3. The configured duration of ramp A and intermediate voltage level depends on individual application requirements.
4. Finally the gate voltage is further reduced by the controlled voltage ramp B until the IGBT is completely switched off and the gate voltage reaches  $V_{EE2}$ .

The gate driver two-level turn-off function can be activated in register **DRVCFG.STD\_OFF**. The behavior can be adjusted with four parameters in the registers **TLTOC1** and **TLTOC2**.

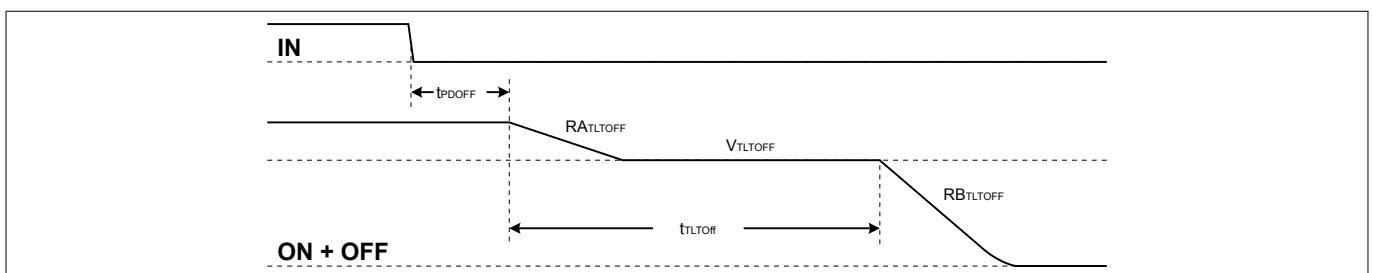


Figure 12 Two-level turn-off timing and ramp-down behavior

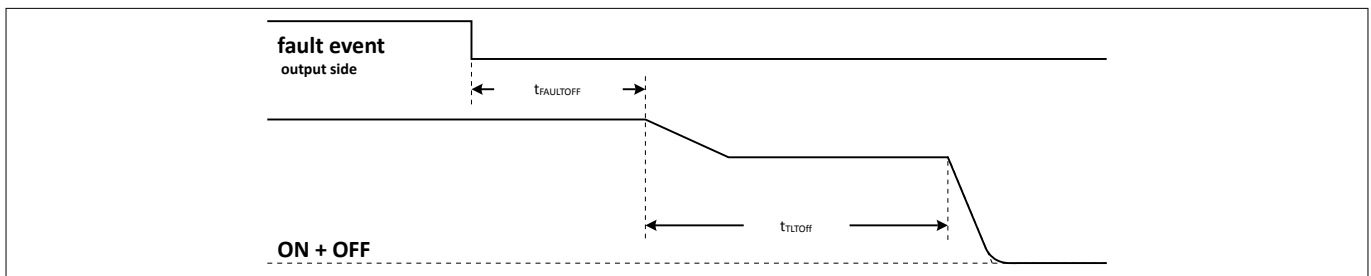
**4 Functional description**

In the two-level turn-off mode, the turn-on propagation delay is a function of the plateau time and the gate driver propagation delay without TLTOff function  $t_{PDOn}$ . This means the gate driver propagation delay will be enlarged by the plateau time for turn-on to ensure a constant on-time of the switch. The two-level turn-off does not change the on-time of an *IN* pulse. The TLTOff voltage will be controlled in a closed loop at the *OFF* output pin of the gate driver IC.

For switch-off initiated by:

- the *IN* signal, the gate driver IC is starting the TLTOff sequence after the propagation delay
- the DESAT function, the gate driver switch-off is delayed by desaturation sense to OFF delay and an optional fault-off delay
- a non-DESAT fault event or a not ready event on output side, the gate driver switch-off occurs immediately or after an optional fault-off delay

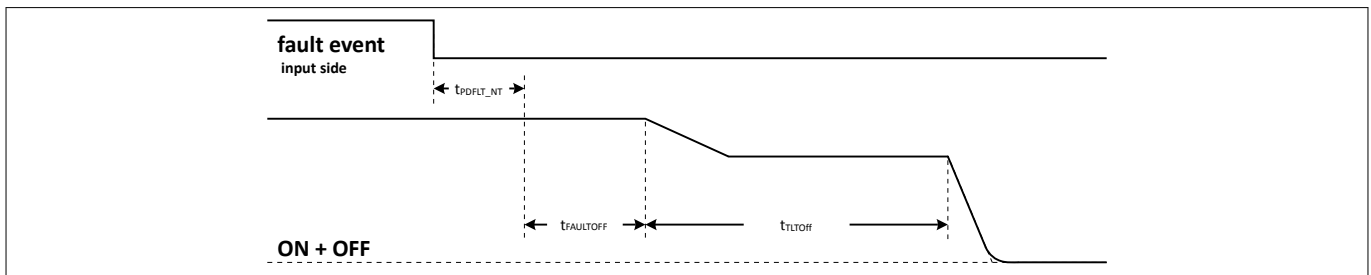
After the elapsed plateau time the gate driver IC switches from the plateau voltage down to *VEE2* voltage.



**Figure 13 Two-level turn-off after fault event (output side)**

For switch-off initiated by:

- *FLT\_N* or *RDYC* signal or an internal fault event from input side, the output is switched off after the propagation delay with an optional fault off delay using the defined fault off function



**Figure 14 Two-level turn-off after fault event (input side)**

**4.9.2.3 Soft turn-off**

The soft turn-off function protects the IGBT against collector-emitter overvoltage during turn off in an overcurrent condition. It turns-off the IGBT with a reduced gate current to reduce the *di/dt* induced overvoltage..

The IGBT gate is connected via *OFF* to an internal current sink circuit. The discharge current is typically lower than the hard switch-off current used for normal operation. Since soft turn-off is a single event after a failure, the gate driver IC can handle the additional power dissipation internally.

The soft turn-off function is implemented as a current source which can be adjusted with a 4 bit value in the register **CSSOFCFG**.

The adjustable range depends on the current strength of the gate driver IC:

- 1ED3830M: 15 mA - 233 mA
- 1ED3860M: 29 mA - 466 mA
- 1ED3890M: 44 mA - 699 mA

**4 Functional description**

**4.9.3 Active shut-down**

The active shut-down feature ensures a safe IGBT off-state, if the output chip is not supplied. It protects the IGBT against a floating gate. The IGBT gate is always clamped via *OFF* to *VEE2*.

**4.9.4 Active Miller clamp**

The 1ED38x0Mc12M family (X3 Digital) is equipped with a configurable active Miller clamp function to protect the IGBT from parasitic turn-on in fast switching applications.

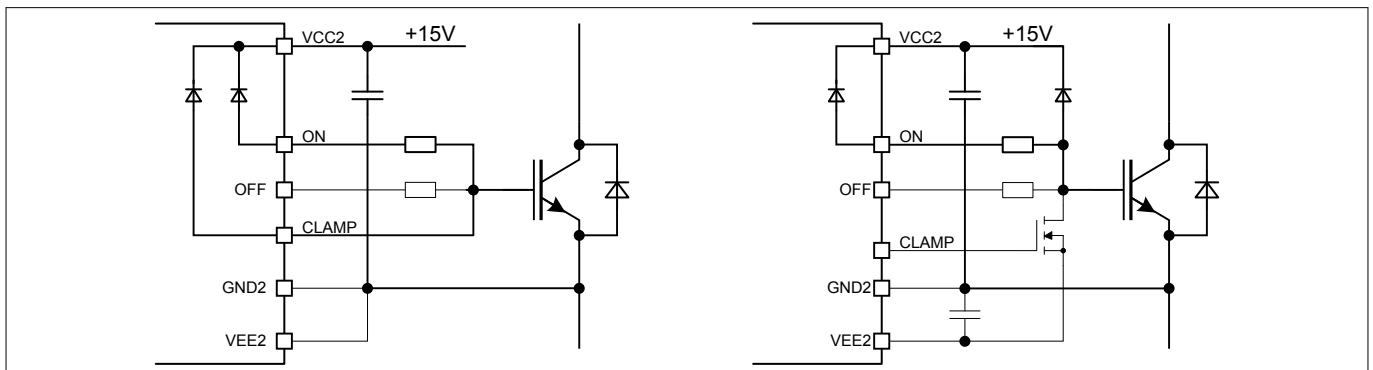
After a turn-off command the gate driver IC follows the implemented sequence:

1. Discharge of the IGBT gate while monitoring the voltage level at the *ON* pin
2. Detection of a voltage at the *ON* pin less than a level of  $VEE2 + 2.0\text{ V}$
3. Filtering of the detection to avoid false CLAMP activation and not to influence regular turn-off behavior
4. Activating clamp function to keep IGBT gate at *VEE2* level

**4.10 Short circuit clamping**

The integrated short circuit clamping diode limits the IGBT gate over voltage during a short circuit. The over voltage is typically triggered by the capacitive feedback of the Miller capacitance.

The internal diodes from *ON* and *CLAMP* to *VCC2* limit the gate driver voltage to a value slightly higher than the supply voltage. These diode paths are rated for a maximum current of 0.75 A and the duration of 6  $\mu\text{s}$ . Add an external Schottky diode if higher currents are expected or a tighter clamping is desired. Also use an external diode if the active Miller clamping circuit uses the pre-driver output configuration.



**Figure 15 Short circuit clamping circuitry**



**5 Electrical parameters**

**5 Electrical parameters**

**5.1 Absolute maximum ratings**

Note: Absolute maximum ratings are defined as ratings, which when being exceeded may lead to destruction of the integrated circuit. Unless otherwise noted all voltages are given with respect to their respective GND (GND1 for pins 1 to 8, GND2 for pins 9 to 16).

**Table 7 Absolute maximum ratings**

Parameter	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Input to output offset voltage	$V_{\text{OFFSET}}$	-	2300	V	$V_{\text{VEE2,max}} - V_{\text{VEE2,min}}$ with $V_{\text{VEE2,max}} \geq V_{\text{GND1}} \geq V_{\text{VEE2,min}}$ <sup>1) 2)</sup>
Supply voltage input side	$V_{\text{VCC1}}$	-0.3	6.5	V	-
Logic input voltage (IN)	$V_{\text{LogicIN}}$	-0.3	6.5	V	-
Logic input voltage (RDYC, FLT_N)	$V_{\text{LogicRF}}$	-0.3	6.5	V	-
I2C logic input voltage (SDA, SCL)	$V_{\text{LogicI2C}}$	-0.3	6.5	V	-
Open drain logic output current (RDYC, FLT_N)	$I_{\text{LogicOC}}$	-	10	mA	-
I2C logic output current (SDA)	$I_{\text{SDA}}$	-	50	mA	-
Positive supply voltage output side	$V_{\text{VCC2}}$	-0.3	40	V	-
Negative supply voltage output side	$V_{\text{VEE2}}$	-40	0.3	V	-
Maximum supply voltage difference output side ( $V_{\text{VCC2}} - V_{\text{VEE2}}$ )	$V_{\text{max2}}$	-	40	V	-
DESAT input voltage	$V_{\text{DESAT}}$	-0.3	$V_{\text{VCC2}} + 0.3$	V	-
CLAMP input voltage	$V_{\text{CLAMP}}$	$V_{\text{VEE2}} - 0.3$	$V_{\text{VCC2}} + 0.3$	V	<sup>3)</sup>
Maximum CLAMP output current	$I_{\text{CLAMP}}$	-	2.4	A	$t < 5 \mu\text{s}$
Gate driver output voltage (ON, OFF)	$V_{\text{OUT}}$	$V_{\text{VEE2}} - 0.3$	$V_{\text{max2}} + 0.3$	V	-
Maximum CLAMP to VCC2 diode IGBT short circuit clamping time	$t_{\text{CLP}}$	-	6	$\mu\text{s}$	$I_{\text{CLAMP/OUT}} = 0.75 \text{ A}$
Junction temperature	$T_{\text{J}}$	-40	150	°C	-
Storage temperature	$T_{\text{Stg}}$	-55	150	°C	-
Power dissipation, input side	$P_{\text{D,IN}}$	-	100	mW	@ $T_{\text{A}} = 25 \text{ °C}$
Power dissipation, output side	$P_{\text{D,OUT}}$	-	700	mW	@ $T_{\text{A}} = 25 \text{ °C}$ <sup>4)</sup>
ESD capability: Human body model	$V_{\text{ESDHBM}}$	-	2	kV	<sup>5)</sup>
ESD capability: Charged device model	$V_{\text{ESDCDM}}$	-	500	V	<sup>6)</sup>

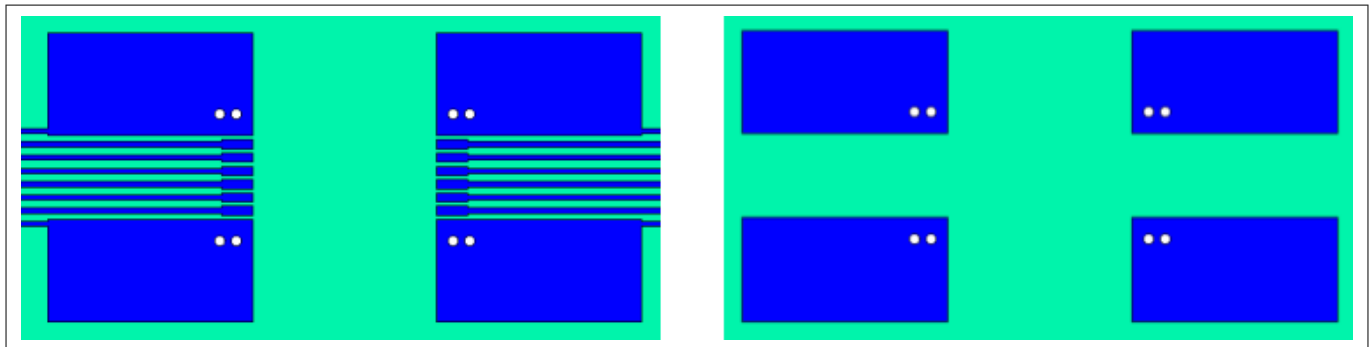
- 1) for functional operation only
- 2) See also [Chapter 6](#) on page 43
- 3) May be exceeded during short circuit clamping.

**5 Electrical parameters**

- 4) Derating the power above 65°C with 8 mW/°C
- 5) According to ANSI/ESDA/JEDEC-JS-001-2017 (discharging a 100 pF capacitor through a 1.5 kΩ series resistor).
- 6) According to ANSI/ESDA/JEDEC-JS-002-2014 (TC = test condition in volt)

**5.2 Thermal parameters**

Thermal performance may change significantly with layout and heat dissipation of components in close proximity.



**Figure 16 Reference layout for thermal data (Two layer PCB; copper thickness 35 μm; left: top layer; right: bottom layer)**

The PCB layout represents the reference layout used for the thermal characterization. Pins 1 and 8 (GND1) and pins 9 and 16 (VEE2) require ground plane connections for achieving maximum power dissipation. The 1ED38x0Mc12M family (X3 Digital) is conceived to dissipate most of the heat generated through these pins.

**Table 8 Thermal parameters**

Parameter	Symbol	Value	Unit	Note / Test Condition
Thermal resistance junction to ambient	$R_{THJA,OUT}$	122	K/W	@ $T_A = 65^\circ\text{C}$ , $P_{D,OUT} = 400\text{ mW}$ , $P_{D,IN} = 50\text{ mW}$ , 4 layer test PCB, PG-DSO-16
Characterization parameter junction to package top input side	$\Psi_{Jtop}$	8	K/W	

**5.3 Operating parameters**

*Note: Within the operating range the IC operates as described in the functional description. Unless otherwise noted all voltages are given with respect to their respective GND (GND1 for pins 1 to 8, GND2 for pins 9 to 16).*

**Table 9 Operating parameters**

Parameter <sup>1)</sup>	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Supply voltage input side	$V_{VCC1}$	3.0	5.5	V	–
Logic input voltages (IN, RDYC, FLT_N, SDA, SCL)	$V_{LogicIN}$	-0.3	5.5	V	–
Positive supply voltage output side	$V_{VCC2}$	13	25	V	–

**(table continues...)**

**5 Electrical parameters**

**Table 9 (continued) Operating parameters**

Parameter <sup>1)</sup>	Symbol	Values		Unit	Note / Test Condition
		Min.	Max.		
Negative supply voltage output side	$V_{VEE2}$	-25	0	V	–
Supply voltage difference output side ( $V_{VCC2} - V_{VEE2}$ )	$V_{max2}$	13	35	V	–
Ambient temperature	$T_A$	-40	125	°C	<sup>2)</sup>
Switching frequency	$f_{SW}$	0	250	kHz	max $P_D$ applies
Common mode transient immunity	$ CMTI $	0	200	V/ns	$V_{OFFSET, test} = 1500\text{ V}$

1) Parameter is not subject to production test - verified by design/characterization

2)  $T_J$  has to be below over temperature protection temperature  $T_{OTPOFF}$

**5 Electrical parameters**

**5.4 Electrical characteristics**

*Note: The electrical characteristics include the spread of values in supply voltages, load, and junction temperatures within the operating parameters and default parameter settings unless specified otherwise. Typical values represent the median values at  $T_A = 25^\circ\text{C}$ . Unless otherwise noted all voltages are given with respect to their respective GND (GND1 for pins 1 to 8, GND2 for pins 9 to 16).*

**5.4.1 Voltage supply**

**Table 10 Voltage supply**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
VCC1 UVLO threshold	$V_{UVLO1H}$	–	2.95	3.05	V	–
	$V_{UVLO1L}$	2.6	2.8	–	V	–
VCC1 UVLO hysteresis ( $V_{UVLO1H} - V_{UVLO1L}$ )	$V_{HYS1}$	0.1	0.14	–	V	–
VCC1 quiescent current	$I_{Q1}$	–	2.4	4.0	mA	$V_{VCC1} = 3.3\text{ V}$ , $IN = \text{High}$ , $RDYC = \text{High}$ , $FLT\_N = \text{High}$
VCC1 operating current	$I_{O1}$	–	2.4	4.0	mA	$V_{VCC1} = 3.3\text{ V}$ , $IN = 16\text{ kHz}$ , $50\%$ , $RDYC = \text{High}$ , $FLT\_N = \text{High}$ , $SCL = \text{Low}$
VCC2 UVLO threshold	$V_{UVLO2H,0}$	–	12.0	12.6	V	<b>UVTLVL.UVVCC2TL = 0<sub>H</sub></b>
	$V_{UVLO2L,0}$	10.4	11.0	–	V	
VCC2 UVLO hysteresis ( $V_{UVLO2H,0} - V_{UVLO2L,0}$ )	$V_{HYS2,0}$	0.75	1.0	–	V	
VCC2 UVLO threshold	$V_{UVLO2H,1}$	–	9.4	10.0	V	<b>UVTLVL.UVVCC2TL = 1<sub>H</sub></b>
	$V_{UVLO2L,1}$	8.0	8.7	–	V	
VCC2 UVLO hysteresis ( $V_{UVLO2H,1} - V_{UVLO2L,1}$ )	$V_{HYS2,1}$	0.6	0.7	–	V	
Soft VCC2 UVLO voltage level	$V_{UV2S,0}$	–	9.5	–	V	<sup>1)</sup> <b>UVSVCC2C.UVSVCC2L</b>
	$V_{UV2S,1}$	–	10.0	–	V	
	...					
	$V_{UV2S,E}$	–	16.5	–	V	
	$V_{UV2S,F}$	–	17.0	–	V	
VEE2 not connected detection threshold	$V_{VEE2,NC}$	–	0.5	–	V	$V_{VEE2} - V_{GND2}$
VEE2 UVLO threshold	$V_{UVLO3H,1}$	-3.6	-3.5	–	V	<b>UVTLVL.UVVEE2TL = 1<sub>H</sub></b>
	$V_{UVLO3L,1}$	–	-3.0	-2.9	V	

**(table continues...)**

**5 Electrical parameters**

**Table 10 (continued) Voltage supply**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
VEE2 UVLO hysteresis ( $V_{UVLO3L,1} - V_{UVLO3H,1}$ )	$V_{HYS3,1}$	0.4	0.5	–	V	
VEE2 UVLO threshold	$V_{UVLO3H,2}$	-6.15	-6	–	V	<b>UVTLVL.UVVEE2TL =</b> $2_H$
	$V_{UVLO3L,2}$	–	-5.5	-5.35	V	
VEE2 UVLO hysteresis ( $V_{UVLO3L,2} - V_{UVLO3H,2}$ )	$V_{HYS3,2}$	0.4	0.5	–	V	
VEE2 UVLO threshold	$V_{UVLO3H,3}$	-12.3	-12.0	–	V	<b>UVTLVL.UVVEE2TL =</b> $3_H$
	$V_{UVLO3L,3}$	–	-11.0	-10.7	V	
VEE2 UVLO hysteresis ( $V_{UVLO3L,3} - V_{UVLO3H,3}$ )	$V_{HYS3,3}$	0.8	1.0	–	V	
Soft VEE2 UVLO voltage level	$V_{UV3S,0}$	–	-2.0	–	V	1) <b>UVSVEE2C.UVSVCC2</b> E
	$V_{UV3S,1}$	–	-3.0	–	V	
			...			
	$V_{UV3S,E}$	–	-16.0	–	V	
	$V_{UV3S,F}$	–	-17.0	–	V	
VCC2 quiescent current	$I_{Q2}$	–	3.9	5	mA	$V_{VCC2} = 15\text{ V}$ , $V_{VEE2} = -8\text{ V}$ , $OUT =$ High, $DESAT =$ Low, <b>DRVCFG.STD_OFF =</b> $0_H$ , <b>DRVFOFF =</b> $00_H/01_H$
VCC2 operating current	$I_{O2}$	–	3.9	5	mA	$V_{VCC2} = 15\text{ V}$ , $V_{VEE2} = -8\text{ V}$ , $OUT = 16\text{ kHz}$ , 50%, $DESAT =$ Low, $C_{LOAD} = 100\text{ pF}$ , <b>DRVCFG.STD_OFF =</b> $0_H$ , <b>DRVFOFF =</b> $00_H/01_H$

1) Parameter is not subject to production test - verified by design/characterization

5 Electrical parameters

5.4.2 Logic input and output

Table 11 Logic input and output

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Logic low input voltage ( <i>IN</i> , <i>RDYC</i> , <i>FLT_N</i> , <i>SDA</i> , <i>SCL</i> )	$V_{\text{LogicINL}}$	–	–	30	%	of $V_{\text{CC1}}$
Logic high input voltage ( <i>IN</i> , <i>RDYC</i> , <i>FLT_N</i> , <i>SDA</i> , <i>SCL</i> )	$V_{\text{LogicINH}}$	70	–	–	%	of $V_{\text{CC1}}$
Logic low output voltage ( <i>RDYC</i> , <i>FLT_N</i> )	$V_{\text{RDYC5}}$ , $V_{\text{FLT_N5}}$	–	–	300	mV	$I_{\text{SINK}} = 5 \text{ mA}$
Logic low output voltage <i>SDA</i>	$V_{\text{SDA20}}$	–	–	400	mV	$I_{\text{SINK}} = 20 \text{ mA}$
Logic input pull down resistor ( <i>IN</i> )	$R_{\text{INPD}}$	33	40	47	k $\Omega$	–
Logic input pull down resistor ( <i>RDYC</i> , <i>FLT_N</i> )	$R_{\text{RDYCPD}}$ , $R_{\text{FLT_NPD}}$	0.8	1.0	1.2	M $\Omega$	–
Logic input current ( <i>SDA</i> , <i>SCL</i> )	$I_{\text{SDA}}$ , $I_{\text{SCL}}$	-10	0	+10	$\mu\text{A}$	$0.1 \cdot V_{\text{CC1}} < V_{\text{I}} < 0.9 \cdot V_{\text{CC1}}$
Logic input pull down resistor ( <i>SDA</i> , <i>SCL</i> )	$R_{\text{SDAPD}}$ , $R_{\text{SCLPD}}$	0.8	1.0	1.2	M $\Omega$	–
Logic pin input capacitance ( <i>SDA</i> , <i>SCL</i> )	$C_{\text{SDA}}$ , $C_{\text{SCL}}$	–	–	10	pF	1)

1) Parameter is not subject to production test - verified by design/characterization

**5 Electrical parameters**

**5.4.3 Gate driver**

Note: High and low level output currents are absolute values without an information of current direction.

**Table 12 Gate driver**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
High level output voltage	$V_{ON0}$	–	$V_{VCC2} + 0.87$	$V_{VCC2} + 1.01$	V	$I_{ON} = 500 \text{ mA}^{1)}$
High level output peak current 1ED3830M	$I_{ON}$	2.6	3.8	–	A	$^{2) 3)} C_{LOAD} = 33 \text{ nF}$
High level output on resistance 1ED3830M	$R_{DSON,H}$	0.51	1.12	2.24	$\Omega$	$I_{ON} = 67 \text{ mA}^{3)}$
Low level output peak current 1ED3830M	$I_{OFF}$	2.0	2.5	–	A	$^{2) 4)} C_{LOAD} = 33 \text{ nF}$
Low level output on resistance 1ED3830M	$R_{DSON,L}$	0.31	0.82	1.64	$\Omega$	$I_{OFF} = 67 \text{ mA}^{4)}$
High level output peak current 1ED3860M	$I_{ON}$	5.2	7.5	–	A	$^{2) 3)} C_{LOAD} = 68 \text{ nF}$
High level output on resistance 1ED3860M	$R_{DSON,H}$	0.26	0.56	1.13	$\Omega$	$I_{ON} = 133 \text{ mA}^{3)}$
Low level output peak current 1ED3860M	$I_{OFF}$	4.0	5.0	–	A	$^{2) 4)} C_{LOAD} = 68 \text{ nF}$
Low level output on resistance 1ED3860M	$R_{DSON,L}$	0.16	0.41	0.83	$\Omega$	$I_{OFF} = 133 \text{ mA}^{4)}$
High Level output peak current 1ED3890M	$I_{ON}$	7.9	11	–	A	$^{2) 3)} C_{LOAD} = 100 \text{ nF}$
High level output on resistance 1ED3890M	$R_{DSON,H}$	0.17	0.38	0.75	$\Omega$	$I_{ON} = 200 \text{ mA}^{3)}$
Low Level output peak current 1ED3890M	$I_{OFF}$	6.0	7.5	–	A	$^{2) 4)} C_{LOAD} = 100 \text{ nF}$
Low level output on resistance 1ED3890M	$R_{DSON,L}$	0.11	0.28	0.55	$\Omega$	$I_{OFF} = 200 \text{ mA}^{4)}$
Active Shut Down Voltage OFF 1ED3830M	$V_{ACTSD}^{5)}$	–	–	$V_{VEE2} + 2.4$	V	$I_{OUT} = 67 \text{ mA}, V_{VCC2}$ open
Active Shut Down Voltage OFF 1ED3860M	$V_{ACTSD}^{5)}$	–	–	$V_{VEE2} + 2.4$	V	$I_{OUT} = 133 \text{ mA}, V_{VCC2}$ open
Active Shut Down Voltage OFF 1ED3890M	$V_{ACTSD}^{5)}$	–	–	$V_{VEE2} + 2.4$	V	$I_{OUT} = 200 \text{ mA}, V_{VCC2}$ open

1) Integrated diode ON vs. VCC2 clamping test

2) Parameter is not subject to production test - verified by design/characterization

3)  $I_N = \text{High}, ON = \text{High}; V_{CC2-ON} = 15 \text{ V}; R_G = 0.1 \Omega; V_{CC2} = 15 \text{ V}; V_{EE2} = -8 \text{ V}$

4)  $I_N = \text{Low}, OFF = \text{Low}; OFF-VEE2 = 15 \text{ V}; R_G = 0.1 \Omega; V_{CC2} = 15 \text{ V}; V_{EE2} = -8 \text{ V}$

**5 Electrical parameters**

5) With reference to  $V_{EE2}$

**5.4.4 Active Miller clamp**

**Table 13 Active Miller clamp**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
High level clamp voltage	$V_{CLAMPH0}$	–	$V_{VCC2} + 1.5$	$V_{VCC2} + 1.63$	V	$I_{CLAMP} = 500 \text{ mA}^{1) 2)}$
	$V_{CLAMPH1}$	–	$V_{VCC2} + 0.9$	$V_{VCC2} + 1.1$	V	$I_{CLAMP} = 50 \text{ mA}^{1) 2)}$
Clamp-driver high level output voltage	$V_{CLAMPDH1}$	$V_{VEE2} + 7.5$	$V_{VEE2} + 9.5$	$V_{VEE2} + 11.5$	V	$I_{CLAMP} = 5 \text{ mA}^{3)}$
	$V_{CLAMPDH2}$	$V_{VEE2} + 4.5$	$V_{VEE2} + 6.7$	–	V	$I_{CLAMP} = 50 \text{ mA}^{3)}$
Clamp-driver high level output peak current	$I_{CLAMP}$	0.20	0.27	–	A	<sup>4)</sup> $V_{CC2} = 15 \text{ V}$ ; $V_{EE2} = 0 \text{ V}$ ; $C_{CLAMP} = 100 \text{ nF}$ ; $R_{CLAMP} = 1 \Omega$
Clamp/Clamp-driver output low level current	$I_{CLAMPL,2}$	1.1	1.8	–	A	<sup>4)</sup> $V_{CC2} = 15 \text{ V}$ ; $V_{EE2} = 0 \text{ V}$ ; $V_{CLAMP} = 2 \text{ V}$ ; $C_{CLAMP} = 100 \text{ nF}$ ; $R_{CLAMP} = 0.1 \Omega$
Clamp/Clamp-driver output low level current	$I_{CLAMPL,5}$	2.2	3.5	–	A	<sup>4)</sup> $V_{CC2} = 15 \text{ V}$ ; $V_{EE2} = 0 \text{ V}$ ; $V_{CLAMP} = 5 \text{ V}$ ; $C_{CLAMP} = 100 \text{ nF}$ ; $R_{CLAMP} = 0.1 \Omega$
Clamp/Clamp-driver output low level ON resistance	$R_{DSON,CLP}$	0.50	0.85	1.35	$\Omega$	$I_{CLAMPL} = 200 \text{ mA}$
Clamp threshold voltage	$V_{ON\_CLAMP}$	1.5	2.0	2.5	V	Related to $V_{EE2}$
Filter time for CLAMP and pin status monitoring	$t_{CLAMPfilter,1}$	90	105	120	ns	<b>CLCFG.CLFLT_T</b>
	$t_{CLAMPfilter,2}$	123	145	167	ns	
	$t_{CLAMPfilter,3}$	159	190	221	ns	
	$t_{CLAMPfilter,4}$	195	235	275	ns	
	$t_{CLAMPfilter,5}$	225	275	325	ns	
	$t_{CLAMPfilter,6}$	263	325	387	ns	
	$t_{CLAMPfilter,7}$	296	370	444	ns	
CLAMP reaction time in CLAMP mode	$t_{CLAMP\_ON}$	16 + $t_{CLAMPfilter}$	23 + $t_{CLAMPfilter}$	35 + $t_{CLAMPfilter}$	ns	<sup>4) 5)</sup> $C_{LOAD} = 100 \text{ pF}$
CLAMP reaction time in CLAMP driver mode	$t_{CLAMPD\_ON}$	24 + $t_{CLAMPfilter}$	35 + $t_{CLAMPfilter}$	53 + $t_{CLAMPfilter}$	ns	<sup>4) 6)</sup> $C_{LOAD} = 100 \text{ pF}$
Switch-off time-out time	$t_{CTT,0}$	–	0.2	–	$\mu\text{s}$	<sup>4)</sup> <b>SOTOUT.SOTOUT_T</b>
	$t_{CTT,1}$	–	0.4	–	$\mu\text{s}$	
	$t_{CTT,2}$	–	0.6	–	$\mu\text{s}$	

**(table continues...)**



5 Electrical parameters

Table 13 (continued) Active Miller clamp

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
	$t_{CTT,3}$	–	0.8	–	$\mu\text{s}$	
	$t_{CTT,4}$	–	1.2	–	$\mu\text{s}$	
	$t_{CTT,5}$	–	1.6	–	$\mu\text{s}$	
	$t_{CTT,6}$	–	2.4	–	$\mu\text{s}$	
	$t_{CTT,7}$	–	3.2	–	$\mu\text{s}$	
Switch-off time-out soft-off offset time	$t_{CTSOOS}$	–	2.4	–	$\mu\text{s}$	<sup>4)</sup> additional time-out delay during soft-off

- 1) Integrated diode *CLAMP* vs. *VCC2* clamping test
- 2) only valid for direct clamping: *IN* = High, *OUT* = High
- 3) only valid for clamp pre-driver output: *IN* = Low, *OUT* = Low
- 4) Parameter is not subject to production test - verified by design/characterization
- 5) *CLAMP* mode reaction time specified with 3.3 k $\Omega$  pull-up from *CLAMP* to 3.3 V, from *CLAMP* threshold until reaching 0.8 V (falling) at *CLAMP* pin
- 6) *CLAMP* driver mode reaction time specified from *CLAMP* threshold until reaching 0.8 V (rising) at *CLAMP(DRV)* pin

### 5.4.5 Dynamic characteristics

Dynamic characteristics are measured with  $V_{VCC1} = 5\text{ V}$ ,  $V_{VCC2} = 15\text{ V}$  and  $V_{VEE2} = -8\text{ V}$ , short filter time (**PSUPR**), hard switch off (**DRVCFG**), and *CLAMP* function activated unless specified otherwise.

Table 14 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Input pulse suppression time <i>IN</i>	$t_{INMIN,0}$	98	103	108	ns	<b>PSUPR.IN_SUPR</b>
	$t_{INMIN,1}$	174	183	192	ns	
Input pulse suppression time <i>RDYC/FLT_N</i> for enable / fault off	$t_{RDYCMIN,0}$	85	100	115	ns	<b>PSUPR.IN_SUPR</b>
	$t_{RDYCMIN,1}$ , $t_{FLT_NMIN,1}$	153	180	207	ns	
Input pulse width <i>RDYC</i> for <i>FLT_N</i> reset (Fault clear time)	$t_{CLRMIN}$	–	1.0	1.2	$\mu\text{s}$	<b>FCLR.FCLR_CFG</b> = 0
Fault self clear time for <i>FLT_N</i> reset	$t_{FSCLR,0}$	–	400	440	$\mu\text{s}$	<b>FCLR.FCLR_CFG</b> = 1, <b>FCLR.FSCLR_T</b>
	$t_{FSCLR,1}$	–	1600	1760	$\mu\text{s}$	
Input pulse suppression for I2C ( <i>SDA</i> , <i>SCL</i> )	$t_{I2CMIN,0}$	41	50	59	ns	<b>PSUPR.IN_SUPR</b>
	$t_{I2CMIN,1}$	74	90	106	ns	
Output fall time for I2C ( <i>SDA</i> )	$t_{I2CFALL}$	20	–	120	ns	<sup>1)</sup> $V_{CC1} = 5\text{ V}$ ; $V_{LogicIN} = V_{VCC1} * 70\% \dots V_{VCC1} * 30\%$

(table continues...)

**5 Electrical parameters**

**Table 14 (continued) Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Input <i>IN</i> to output propagation delay <i>ON</i>	$t_{PDON}$	226	244	270	ns	$C_{LOAD} = 100 \text{ pF}$ , $V_{IN} = 70\%$ , $V_{OUT}=20\%$ , with $t_{INMIN,0}$
Input <i>IN</i> to output propagation delay <i>OFF</i>	$t_{PDOFF}$	218	236	262	ns	$C_{LOAD} = 100 \text{ pF}$ , $V_{IN} = 30\%$ , $V_{OUT}=80\%$ , with $t_{INMIN,0}$
Input to output propagation delay distortion ( $t_{PDOFF} - t_{PDON}$ )	$t_{PDISTO}$	-23	-8	7	ns	$C_{LOAD} = 100 \text{ pF}$
Input <i>IN</i> to output propagation delay distortion between any devices ( $t_{PDON}-t_{PDON}$ ) or ( $t_{PDOFF}-t_{PDOFF}$ )	$t_{PDD}$	-	-	30	ns	<sup>1)</sup> same conditions ( $V_{IN}$ , $V_{VCC1}$ , $V_{VCC2}$ and $V_{VEE2}$ , $C_{LOAD}$ , $T_A$ , $t_{INMIN,0}$ )
State synchronization time between input and output	$t_{SSIO}$	-	-	13	$\mu\text{s}$	<sup>1)</sup>
Input <i>RDYC</i> to output on propagation delay	$t_{PDRDYC}$	447	523	600	ns	$C_{LOAD} = 100 \text{ pF}$ ; <i>IN</i> high; $V_{RDYC} = 70\%$ , $V_{OUT}=20\%$ , with $t_{INMIN,0}$
Input <i>RDYC</i> or <i>FLT_N</i> to Soft-off output propagation delay	$t_{PDRDYCS}$ , $t_{PDFLT\_NS}$	323	361	407	ns	$C_{LOAD} = 100 \text{ pF}$ , $V_{Signal} = 30\%$ , $V_{OUT}=80\%$ , with $t_{MINRDYC,0}$ , Soft-off function $I_{CSOFF,15}$
Input <i>RDYC</i> or <i>FLT_N</i> to hard switch-off output propagation delay	$t_{PDRDYCH}$ , $t_{PDFLT\_NH}$	303	342	384	ns	$C_{LOAD} = 100 \text{ pF}$ , $V_{Signal} = 30\%$ , $V_{OUT}=80\%$ , with $t_{MINRDYC,0}$ , OFF function
Input <i>RDYC</i> or <i>FLT_N</i> to TLTOff output propagation delay 1ED3830M	$t_{PDRDYCT}$ , $t_{PDFLT\_NT}$	330	387	452	ns	$C_{LOAD} = 100 \text{ pF}$ , $V_{Signal} = 30\%$ , $V_{OUT}=80\%$ , with $t_{MINRDYC,0}$ , TLTOff function,
Input <i>RDYC</i> or <i>FLT_N</i> to TLTOff output propagation delay 1ED3860M	$t_{PDRDYCT}$ , $t_{PDFLT\_NT}$	360	417	482	ns	<b>TLTOC1</b> .TLTO_RA = 3 <sub>H</sub> ; .TLTO_V = 13 <sub>H</sub> ; <b>DRVCFG</b> .TLTO_GCH = 3 <sub>H</sub>
Input <i>RDYC</i> or <i>FLT_N</i> to TLTOff output propagation delay 1ED3890M	$t_{PDRDYCT}$ , $t_{PDFLT\_NT}$	390	447	512	ns	
	$t_{FAULTOFF,00}$	-	0	-	$\mu\text{s}$	

**(table continues...)**

**5 Electrical parameters**

**Table 14 (continued) Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Fault off event to fault off delay time	$t_{\text{FAULTOFF},01}$	-5%	0.263	+5%	$\mu\text{s}$	<b>F20DLY.F20_DLY</b> Step size 0.25 $\mu\text{s}$ , initial step is 12.5 ns longer
	$t_{\text{FAULTOFF},02}$	-5%	0.513	+5%	$\mu\text{s}$	
			...			
	$t_{\text{FAULTOFF},1E}$	-5%	7.513	+5%	$\mu\text{s}$	
	$t_{\text{FAULTOFF},1F}$	-5%	7.763	+5%	$\mu\text{s}$	
Rise time 1ED3830M	$t_{\text{RISE}}$	-	15	30	ns	$C_{\text{LOAD}} = 1 \text{ nF}$ , $V_{\text{OUT}}$ : 20% to 80%
Fall time 1ED3830M	$t_{\text{FALL}}$	-	15	30	ns	$C_{\text{LOAD}} = 1 \text{ nF}$ , $V_{\text{OUT}}$ : 80% to 20%
Rise time 1ED3860M	$t_{\text{RISE}}$	-	15	30	ns	$C_{\text{LOAD}} = 2.2 \text{ nF}$ , $V_{\text{OUT}}$ : 20% to 80%
Fall Time 1ED3860M	$t_{\text{FALL}}$	-	15	30	ns	$C_{\text{LOAD}} = 2.2 \text{ nF}$ , $V_{\text{OUT}}$ : 80% to 20%
Rise Time 1ED3890M	$t_{\text{RISE}}$	-	15	30	ns	$C_{\text{LOAD}} = 3.3 \text{ nF}$ , $V_{\text{OUT}}$ : 20% to 80%
Fall Time 1ED3890M	$t_{\text{FALL}}$	-	15	30	ns	$C_{\text{LOAD}} = 3.3 \text{ nF}$ , $V_{\text{OUT}}$ : 80% to 20%

1) Parameter is not subject to production test - verified by design/characterization

**5.4.6 Desaturation protection**

All parameters valid for  $V_{\text{CC1}} = 5 \text{ V}$ ,  $V_{\text{CC2}} = 15 \text{ V}$ , and  $V_{\text{EE2}} = 0 \text{ V}$  unless specified otherwise.

**Table 15 Desaturation protection**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
DESAT charge current	$I_{\text{DESATC}}$	470	500	525	$\mu\text{A}$	$V_{\text{DESAT}} = 0 \text{ V}$
DESAT voltage divider resistance	$R_{\text{DVD}}$	259	312.5	366	k $\Omega$	between <i>DESAT</i> and <i>GND2</i> pins
DESAT clamp and discharge ON resistance	$R_{\text{DSON,D}}$	-	7.7	25.0	$\Omega$	$I_{\text{DESATD}} = 200 \text{ mA}$
DESAT threshold level	$V_{\text{DESAT},1F}$	8.88	9.18	9.48	V	<b>D1LVL.D1_V_LVL</b> , <b>D2LVL.D2_V_LVL</b>
	$V_{\text{DESAT},1E}$	8.50	8.89	8.99	V	
	$V_{\text{DESAT},1D}$	8.23	8.61	8.70	V	
	$V_{\text{DESAT},1C}$	7.96	8.33	8.70	V	
	$V_{\text{DESAT},1B}$	7.68	8.05	8.42	V	

(table continues...)

5 Electrical parameters

Table 15 (continued) Desaturation protection

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
	$V_{DESAT,1A}$	7.41	7.77	8.13	V	
	$V_{DESAT,19}$	7.14	7.49	7.84	V	
	$V_{DESAT,18}$	6.86	7.20	7.54	V	
	$V_{DESAT,17}$	6.63	6.96	7.29	V	
	$V_{DESAT,16}$	6.36	6.68	7.00	V	
	$V_{DESAT,15}$	6.08	6.40	6.72	V	
	$V_{DESAT,14}$	5.81	6.12	6.43	V	
	$V_{DESAT,13}$	5.54	5.84	6.14	V	
	$V_{DESAT,12}$	5.26	5.55	5.84	V	
	$V_{DESAT,11}$	4.99	5.27	5.55	V	
	$V_{DESAT,10}$	4.72	4.99	5.26	V	
	$V_{DESAT,0F}$	4.52	4.79	5.06	V	
	$V_{DESAT,0E}$	4.33	4.59	4.85	V	
	$V_{DESAT,0D}$	4.13	4.39	4.65	V	
	$V_{DESAT,0C}$	3.94	4.19	4.44	V	
	$V_{DESAT,0B}$	3.73	3.98	4.23	V	
	$V_{DESAT,0A}$	3.54	3.78	4.02	V	
	$V_{DESAT,09}$	3.35	3.58	3.81	V	
	$V_{DESAT,08}$	3.16	3.38	3.60	V	
	$V_{DESAT,07}$	2.96	3.18	3.40	V	
	$V_{DESAT,06}$	2.77	2.98	3.19	V	
	$V_{DESAT,05}$	2.57	2.78	2.99	V	
	$V_{DESAT,04}$	2.38	2.58	2.78	V	
	$V_{DESAT,03}$	2.17	2.37	2.57	V	
	$V_{DESAT,02}$	2.02	2.21	2.40	V	
	$V_{DESAT,01}$	1.83	2.01	2.19	V	
	$V_{DESAT,00}$	1.67	1.85	2.03	V	
DESAT leading edge blanking time	$t_{DESATleb,00}$	65	100	134	ns	<b>DLEBT.D_LEB_T</b> , $V_{ON}$ 20% rising to $V_{DESAT} = 1\text{ V}$ , $C_{LOAD} = 100\text{ pF}$ , $C_{DESAT} = 2\text{ pF}$ , $t_{FAULTOFF,00}$
	$t_{DESATleb,01}$	163	200	237	ns	
	$t_{DESATleb,02}$	211	250	288	ns	
			...			
	$t_{DESATleb,3E}$	3094	3250	3406	ns	
	$t_{DESATleb,3F}$	3142	3300	3458	ns	

(table continues...)

5 Electrical parameters

Table 15 (continued) Desaturation protection

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
DESAT filter time	$t_{DESATfilter,00}$	–	–	–	ns	<b>D1FILT.D1FILT_T</b> , <b>D2FILT.D2FILT_T</b>
	$t_{DESATfilter,01}$	48	75	105	ns	
		–	...	–	ns	
	$t_{DESATfilter,06}$	286	325	368	ns	
	$t_{DESATfilter,07}$	333	375	421	ns	
	$t_{DESATfilter,08}$	429	475	526	ns	
			...			
	$t_{DESATfilter,0E}$	1000	1075	1158	ns	
	$t_{DESATfilter,0F}$	1095	1175	1263	ns	
	$t_{DESATfilter,10}$	1286	1375	1474	ns	
			...			
	$t_{DESATfilter,16}$	2429	2575	2737	ns	
	$t_{DESATfilter,17}$	2619	2775	2947	ns	
	$t_{DESATfilter,18}$	3000	3175	3368	ns	
			...			
$t_{DESATfilter,1E}$	5286	5575	5895	ns		
$t_{DESATfilter,1F}$	5667	5975	6316	ns		
DESAT1 sense to <i>FLT_N</i> low delay	$t_{DESAT1FLT}$	623	743	883	ns	$V_{FLT\_N} = 30\%$ , $I_{FLT\_N} = 5\text{ mA}$ , $t_{DESATfilter,04}$ , $C_{FLT\_N} = 100\text{ pF}$
DESAT2 sense to <i>FLT_N</i> low delay	$t_{DESAT2FLT}$	673	793	933	ns	
DESAT1 sense to <i>OFF</i> low delay, Soft-off	$t_{DESAT1OUTS}$	287 + $t_{DESATfilter}$	333 + $t_{DESATfilter}$	382 + $t_{DESATfilter}$	ns	$V_{OUT} = 80\%$ , $C_{LOAD} = 100\text{ pF}$ , $t_{FAULTOFF,n} = 0\text{ }\mu\text{s}$ , $I_{CSOFF,15}$
DESAT2 sense to <i>OFF</i> low delay, Soft-off	$t_{DESAT2OUTS}$	337 + $t_{DESATfilter}$	383 + $t_{DESATfilter}$	432 + $t_{DESATfilter}$	ns	
DESAT1 sense to <i>OFF</i> low delay, TLTOff, 1ED3830M	$t_{DESAT1OUTT3}$	294 + $t_{DESATfilter}$	359 + $t_{DESATfilter}$	427 + $t_{DESATfilter}$	ns	$V_{OUT} = 80\%$ , $C_{LOAD} = 100\text{ pF}$ , $t_{FAULTOFF,n} = 0\text{ }\mu\text{s}$ , <b>TLTOC1.TLTO_RA</b> = 3 <sub>H</sub> , <b>TLTOC1.TLTO_V</b> = 13 <sub>H</sub> , <b>DRVCFG.TLTO_GCH</b> = 3 <sub>H</sub>
DESAT1 sense to <i>OFF</i> low delay, TLTOff, 1ED3860M	$t_{DESAT1OUTT6}$	324 + $t_{DESATfilter}$	389 + $t_{DESATfilter}$	457 + $t_{DESATfilter}$	ns	
DESAT1 sense to <i>OFF</i> low delay, TLTOff, 1ED3890M	$t_{DESAT1OUTT9}$	354 + $t_{DESATfilter}$	419 + $t_{DESATfilter}$	487 + $t_{DESATfilter}$	ns	
	$t_{DESAT2OUTT3}$	344 + $t_{DESATfilter}$	409 + $t_{DESATfilter}$	477 + $t_{DESATfilter}$	ns	

(table continues...)

**5 Electrical parameters**

**Table 15 (continued) Desaturation protection**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
DESAT2 sense to <i>OFF</i> low delay , TLTOff, 1ED3830M						
DESAT2 sense to <i>OFF</i> low delay , TLTOff, 1ED3860M	$t_{DESAT2OUTT6}$	374 + $t_{DESATfilter}$	439 + $t_{DESATfilter}$	507 + $t_{DESATfilter}$	ns	
DESAT2 sense to <i>OFF</i> low delay , TLTOff, 1ED3890M	$t_{DESAT2OUTT9}$	404 + $t_{DESATfilter}$	469 + $t_{DESATfilter}$	537 + $t_{DESATfilter}$	ns	
DESAT1 sense to <i>OFF</i> low delay, hard switch- off	$t_{DESAT1OUTH}$	267 + $t_{DESATfilter}$	314 + $t_{DESATfilter}$	359 + $t_{DESATfilter}$	ns	$V_{OUT} = 80\%$ , $C_{LOAD} = 100\text{ pF}$ , $t_{FAULTOFF,n} = 0\text{ }\mu\text{s}$
DESAT2 sense to <i>OFF</i> low delay, hard switch- off	$t_{DESAT2OUTH}$	317 + $t_{DESATfilter}$	364 + $t_{DESATfilter}$	409 + $t_{DESATfilter}$	ns	

5 Electrical parameters

5.4.7 Two-level turn-off

Table 16 Two-level turn-off

Parameter <sup>1)</sup>	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Two-level turn-off time <sup>2)</sup>	$t_{TLTOff,00}$	-	0	-	$\mu\text{s}$	<b>TLTOC2.TLTO_T</b> ; $C_{LOAD} = 100 \text{ pF}$ ; $t_{MININ,0}$ ; $V_{VCC2} = 15 \text{ V}$ ; $V_{VEE2} = -8 \text{ V}$ ; $V_{VCC1} = 5 \text{ V}$ ; $RA_{TLTOff,3}$ ; $RB_{TLTOff,0}$ ; $V_{TLTOff,13}$
	$t_{TLTOff,01}$	-5%	0.25	+5%	$\mu\text{s}$	
		-	...	-		
	$t_{TLTOff,1E}$	-5%	7.50	+5%	$\mu\text{s}$	
	$t_{TLTOff,1F}$	-5%	7.75	+5%	$\mu\text{s}$	
Two-level turn-off ramp A	$RA_{TLTOff,0}$	-	7.5	-	$\text{V}/\mu\text{s}$	<b>TLTOC1.TLTO_RA</b>
	$RA_{TLTOff,1}$	-	15	-	$\text{V}/\mu\text{s}$	
	$RA_{TLTOff,2}$	-	30	-	$\text{V}/\mu\text{s}$	
	$RA_{TLTOff,3}$	-	60	-	$\text{V}/\mu\text{s}$	
Two-level turn-off ramp B	$RB_{TLTOff,4}$	-	7.5	-	$\text{V}/\mu\text{s}$	<b>TLTOC2.TLTO_RB</b>
	$RB_{TLTOff,5}$	-	15	-	$\text{V}/\mu\text{s}$	
	$RB_{TLTOff,6}$	-	30	-	$\text{V}/\mu\text{s}$	
	$RB_{TLTOff,7}$	-	60	-	$\text{V}/\mu\text{s}$	
	$RB_{TLTOff,0}$	-	max	-	$\text{V}/\mu\text{s}$	hard switch-off, not controlled, compare to driver fall time
Two-level turn-off plateau voltage	$V_{TLTOff,00}$	-	4.25	-	V	<b>TLTOC1.TLTO_V</b>
	$V_{TLTOff,01}$	-	4.5	-	V	
		-	...	-		
	$V_{TLTOff,1E}$	-	11.75	-	V	
	$V_{TLTOff,1F}$	-	12.0	-	V	

- 1) Parameter is not subject to production test - verified by design/characterization  
 2) Two-level turn-off time defined as: Time from turn-off threshold ( $V_{IN}=30\%$ ) to output off detection threshold ( $V_{OFF}=V_{VEE2}+2 \text{ V}$ ) minus turn-off propagation delay  $t_{PDOFF}$

**5 Electrical parameters**

**5.4.8 Soft-off current source**

Soft-off current source values specified at OFF pin at  $V_{OFF} = 3\text{ V}$  with unipolar supply of  $V_{VCC2} = 15\text{ V}$ .

**Table 17 Current source turn-off**

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Soft-off current source current 1ED3830M	$I_{CSOFF,0}$	10	15	19	mA	CSSOFCFG.CSSOFF_I
	$I_{CSOFF,1}$	24	29	36	mA	
	$I_{CSOFF,2}$	35	44	52	mA	
	$I_{CSOFF,3}$	47	58	70	mA	
	$I_{CSOFF,4}$	58	73	87	mA	
	$I_{CSOFF,5}$	70	87	105	mA	
	$I_{CSOFF,6}$	82	102	122	mA	
	$I_{CSOFF,7}$	93	116	140	mA	
	$I_{CSOFF,8}$	105	131	157	mA	
	$I_{CSOFF,9}$	116	146	175	mA	
	$I_{CSOFF,10}$	128	160	192	mA	
	$I_{CSOFF,11}$	140	175	210	mA	
	$I_{CSOFF,12}$	151	189	227	mA	
	$I_{CSOFF,13}$	163	204	245	mA	
	$I_{CSOFF,14}$	175	218	262	mA	
$I_{CSOFF,15}$	186	233	280	mA		
Soft-off current source current 1ED3860M	$I_{CSOFF,0}$	22	29	36	mA	CSSOFCFG.CSSOFF_I
	$I_{CSOFF,1}$	45	58	72	mA	
	$I_{CSOFF,2}$	70	87	105	mA	
	$I_{CSOFF,3}$	93	116	140	mA	
	$I_{CSOFF,4}$	116	146	175	mA	
	$I_{CSOFF,5}$	140	175	210	mA	
	$I_{CSOFF,6}$	163	204	245	mA	
	$I_{CSOFF,7}$	186	233	280	mA	
	$I_{CSOFF,8}$	210	262	314	mA	
	$I_{CSOFF,9}$	233	291	349	mA	
	$I_{CSOFF,10}$	256	320	384	mA	
	$I_{CSOFF,11}$	280	349	419	mA	
	$I_{CSOFF,12}$	303	379	454	mA	
	$I_{CSOFF,13}$	326	408	489	mA	
	$I_{CSOFF,14}$	349	437	524	mA	

(table continues...)



5 Electrical parameters

Table 17 (continued) Current source turn-off

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
	$I_{CSOFF,15}$	373	466	559	mA	
Soft-off current source current 1ED3890M	$I_{CSOFF,0}$	34	44	54	mA	CSSOFFCFG.CSSOFF_I
	$I_{CSOFF,1}$	70	87	105	mA	
	$I_{CSOFF,2}$	105	131	157	mA	
	$I_{CSOFF,3}$	140	175	210	mA	
	$I_{CSOFF,4}$	175	218	262	mA	
	$I_{CSOFF,5}$	210	262	314	mA	
	$I_{CSOFF,6}$	245	306	367	mA	
	$I_{CSOFF,7}$	280	349	419	mA	
	$I_{CSOFF,8}$	314	393	472	mA	
	$I_{CSOFF,9}$	349	437	524	mA	
	$I_{CSOFF,10}$	384	480	577	mA	
	$I_{CSOFF,11}$	419	524	629	mA	
	$I_{CSOFF,12}$	454	568	681	mA	
	$I_{CSOFF,13}$	489	612	734	mA	
	$I_{CSOFF,14}$	524	655	786	mA	
$I_{CSOFF,15}$	559	699	839	mA		

5.4.9 Over-temperature protection

Table 18 Over-temperature protection and over-temperature warning

Parameter <sup>1)</sup>	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Over-temperature protection level	$T_{OTPOFF}$	150	160	170	°C	
Over-temperature warning level	$T_{OTW,7}$	-	95	-	°C	OTWCFFG.OTW_LVL
	$T_{OTW,6}$	-	101	-	°C	
	$T_{OTW,5}$	-	108	-	°C	
	$T_{OTW,4}$	-	114	-	°C	
	$T_{OTW,3}$	-	120	-	°C	
	$T_{OTW,2}$	-	127	-	°C	
	$T_{OTW,1}$	-	134	-	°C	
	$T_{OTW,0}$	-	140	-	°C	

**5 Electrical parameters**

1) Parameter is not subject to production test - verified by design/characterization

**5.4.10 ADC measurement**

**Table 19 ADC voltage and temperature measurement**

Parameter <sup>1)</sup>	Symbol	Values			Unit	Note or Test Condition
		Min.	Typ.	Max.		
Internal ADC voltage max	$V_{ADCINTmax}$	-	38.67	-	V	<b>ADCMVCC2/ ADCMGND2/ ADCMVDIF = FF<sub>H</sub></b>
Internal ADC voltage resolution	$V_{ADCINTres}$	-	151.5	-	mV	
External ADC voltage max	$V_{ADCEXTmax}$	-	2.86	-	V	<b>ADCMVEXT = FF<sub>H</sub></b>
External ADC voltage resolution	$V_{ADCEXTres}$	-	11.2	-	mV	
Internal temperature ADC max	$T_{ADCTEMPmax}$	140	150	160	°C	<b>ADCMTEMP = 84<sub>H</sub></b>
Internal temperature ADC min	$T_{ADCTEMPmin}$	-	-40	-	°C	<b>ADCMTEMP = 49<sub>H</sub></b>
Internal temperature ADC resolution	$T_{ADCTEMPres}$	-	3.21	-	°C	

1) Parameter is not subject to production test - verified by design/characterization

**6 Insulation characteristics**

**6 Insulation characteristics**

The following isolation classes are available for the 1ED38x0Mc12M family (X3 Digital).

**Table 20 Product isolation classes**

Product name	Marking	Insulation characteristics	Values specified in	UL values
1ED38x0MU12M	38x0MU12	UL 1577 certified insulation	-	Table 23
1ED38x0MC12M	38x0MC12	Reinforced insulation	Table 22	Table 23

**Table 21 Safety limiting values**

This coupler is suitable for rated insulation only within the given safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

Description	Symbol	Characteristic	Unit
Maximum ambient safety temperature	$T_S$	150	°C
Maximum input-side power dissipation at $T_A = 25^\circ\text{C}$	$P_{SI}$	100	mW
Maximum output-side power dissipation at $T_A = 25^\circ\text{C}^{1)}$	$P_{SO}$	1000	mW
Maximum driver output current (ON, OFF) <sup>2)</sup>	$I_{OUT}$		A
1ED3830MC		2.4	
1ED3860MC		4.8	
1ED3890MC		7.2	

1) IC output-side power dissipation is derated linearly at 8 mW/°C above 65 °C

2) Maximum pulse length of  $t = 5 \mu\text{s}$

**6.1 Certified according to VDE 0884-11 reinforced insulation (Certificate no. 40053980)**

Valid for parts with part name 1ED38x0MC12M, x indicate different variants.

This coupler is suitable for safe electrical insulation only within the safety ratings. Compliance with the safety ratings shall be ensured by means of suitable protective circuits.

**Table 22 Reinforced insulation according to VDE 0884-11**

Description	Symbol	Characteristic	Unit
Installation classification per EN 60664-1, Table 1 for rated mains voltage $\leq 150 \text{ V (rms)}$ for rated mains voltage $\leq 300 \text{ V (rms)}$ for rated mains voltage $\leq 600 \text{ V (rms)}$ for rated mains voltage $\leq 1000 \text{ V (rms)}$		I-IV I-IV I-III I-II	-
Climatic classification		40/125/21	-
Pollution degree (EN 60664-1)		2	-
Minimum external clearance	CLR	>8	mm
Minimum external creepage	CPG	>8	mm
Minimum comparative tracking index	CTI	400	-

**(table continues...)**

**6 Insulation characteristics**

**Table 22 (continued) Reinforced insulation according to VDE 0884-11**

<b>Description</b>	<b>Symbol</b>	<b>Characteristic</b>	<b>Unit</b>
Apparent charge, method a $V_{pd(ini),a} = V_{IOTM}$ , $V_{pd(m)} = 1.6 \times V_{IORM}$ , $t_{ini} = 1 \text{ min}$	$q_c$	<5	pC
Apparent charge, method b $V_{pd(ini),b} = V_{IOTM} \times 1.2$ , $V_{pd(m)} = 1.875 \times V_{IORM}$ , $t_{ini} = 1 \text{ s}$	$q_c$	<5	pC
Isolation resistance at $T_{A,max}$	$R_{IO}$	$> 10^{11}$	$\Omega$
Isolation resistance at $T_S$	$R_{IO,S}$	$> 10^9$	$\Omega$
Maximum rated transient isolation voltage	$V_{IOTM}$	8000	V (peak)
Maximum repetitive insulation voltage	$V_{IORM}$	1767	V (peak)
Maximum surge isolation voltage for reinforced isolation $V_{TEST} = V_{IOSM} \times 1.6$	$V_{IOSM}$	6875	V (peak)
Insulation capacitance	$C_{IO}$	1.7	pF

**6.2 Recognized under UL 1577 (File E311313)**

**Table 23 Recognized under UL 1577**

<b>Description</b>	<b>Symbol</b>	<b>Characteristic</b>	<b>Unit</b>
Insulation withstand voltage/1 min	$V_{ISO}$	5700	V (rms)
Insulation test voltage/1 s	$V_{ISO,TEST}$	6840	V (rms)

7 Package information

7 Package information

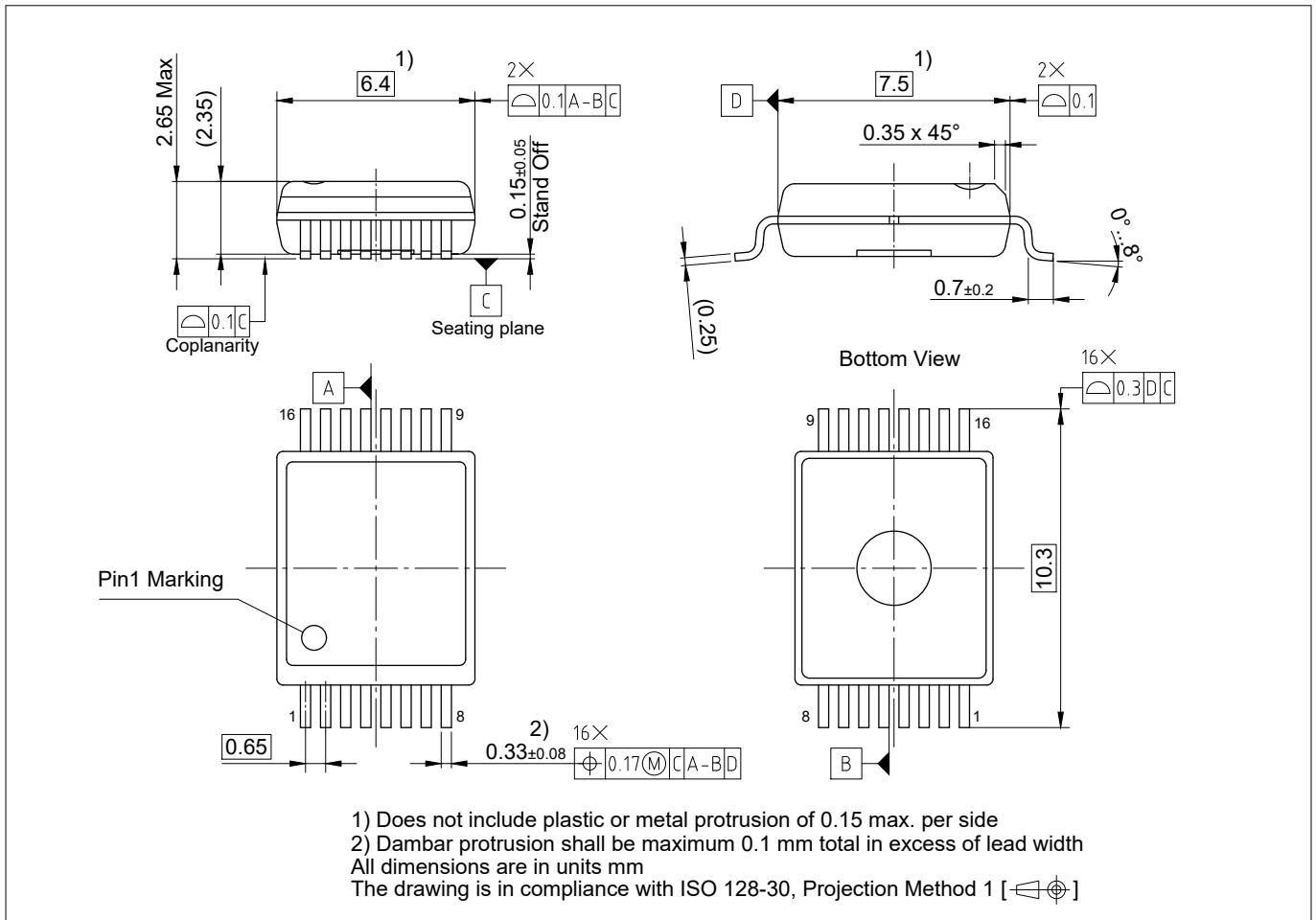


Figure 17 PG-DSO-16-28/33 - 300 mil 16-pin fine pitch plastic green dual small outline package

Revision history

Reference	Description
v2.1 (2021-02-15)	<ul style="list-style-type: none"> <li>Change footnotes to tablenotes, added parameter <math>V_{OFFSET}</math></li> <li>Product links and certification information update</li> </ul>
(2021-09-01)	New version number schema: Target/Preliminary datasheet: 0.XY; Final datasheet: 1.XY
1.10 (2021-10-08)	<ul style="list-style-type: none"> <li>Certification information update (VDE certification)</li> <li>Fix unit and conditions in certification table according to standards</li> <li>Related product list update</li> </ul>

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**Edition 2021-10-08**

**Published by  
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